

128Mb 3V SERIAL FLASH MEMORY WITH 133MHZ MULTI I/O SPI & QUAD I/O QPI DTR INTERFACE

DATA SHEET



128Mb

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FEATURES

• Industry Standard Serial Interface

- XM25QH128B: 128Mbit/16Mbyte
- 256 bytes per Programmable Page
- Supports standard SPI, Fast, Dual, Dual I/O, Quad I/O, SPI DTR, Dual I/O DTR, Quad I/O DTR, and QPI
- Double Transfer Rate (DTR) option
- Supports Serial Flash Discoverable Parameters (SFDP)

• High Performance Serial Flash (SPI)

- 133Mhz Fast Read at Vcc=2.7V to 3.6V
- 104Mhz Fast Read at Vcc=2.3V to 3.6V
- 532MHz equivalent at QPI operation
- 50MHz Normal Read
- DTR (Dual Transfer Rate) up to 66MHz
- Selectable dummy cycles
- Configurable drive strength
- Supports SPI Modes 0 and 3
- Minimum 100,000 erase/program cycles
- More than 20-year data retention

• Flexible & Efficient Memory Architecture

- Chip Erase with Uniform Sector/Block Erase (4/32/64 Kbyte)
- Program 1 to 256 bytes per page
- Program/Erase Suspend & Resume

Efficient Read and Program modes

- Low Instruction Overhead Operations
- Continuous Read 8/16/32/64-Byte Burst Wrap
- Selectable burst length
- QPI for reduced instruction overhead

• Low Power with Wide Temp. Ranges

- Single 2.3V to 3.6V Voltage Supply
- 5 mA Active Read Current
- 10 µA Standby Current
- 5 µA Deep Power Down
- Temp Grades: Industrial: -40°C to +85°C

Advanced Security Protection

- Software and Hardware Write Protection
- Power Supply lock protect
- 4x256-Byte dedicated security area with OTP user-lockable bits
- 128 bit Unique ID for each device (Call Factory)

• Industry Standard Pin-out & Packages⁽¹⁾

- H = SOP 208mil 8L
- W = WSON 5x6mm 8L
- B= TFBGA 6x8mm 24-ball (4x6 ball array)
- B2 = TFBGA 6x8mm 24-ball (5x5 ball array) (Call Factory)
- KGD (Call Factory)



GENERAL DESCRIPTION

The XM25QH128B Serial Flash memory offers a versatile storage solution with high flexibility and performance in a simplified pin count package. XMC's "Industry Standard Serial Interface" Flash are for systems that require limited space, a low pin count, and low power consumption. The device is accessed through a 4-wire SPI Interface consisting of a Serial Data Input (SI), Serial Data Output (SO), Serial Clock (SCK), and Chip Enable (CE#) pins, which can also be configured to serve as multi-I/O (see pin descriptions).

The device supports Dual and Quad I/O as well as standard and Dual Output SPI. Clock frequencies of up to 133MHz allow for equivalent clock rates of up to 532MHz (133MHz x 4) which equates to 66Mbytes/s of data throughput. The XM25Qx series of Flash adds support for DTR (Double Transfer Rate) commands that transfer addresses and read data on both edges of the clock. These transfer rates can outperform 16-bit Parallel Flash memories allowing for efficient memory access to support XIP (execute in place) operation.

The memory array is organized into programmable pages of 256-bytes. This family supports page program mode where 1 to 256 bytes of data are programmed in a single command. QPI (Quad Peripheral Interface) supports 2-cycle instruction further reducing instruction times. Pages can be erased in groups of 4Kbyte sectors, 32Kbyte blocks, 64Kbyte blocks, and/or the entire chip. The uniform sector and block architecture allows for a high degree of flexibility so that the device can be utilized for a broad variety of applications requiring solid data retention.

GLOSSARY

Standard SPI

In this operation, a 4-wire SPI Interface is utilized, consisting of Serial Data Input (SI), Serial Data Output (SO), Serial Clock (SCK), and Chip Enable (CE#) pins. Instructions are sent via the SI pin to encode instructions, addresses, or input data to the device on the rising edge of SCK. The SO pin is used to read data or to check the status of the device. This device supports SPI bus operation modes (0,0) and (1,1).

Multi I/O SPI

Multi-I/O operation utilizes an enhanced SPI protocol to allow the device to function with Dual Output, Dual Input and Output, Quad Output, and Quad Input and Output capability. Executing these instructions through SPI mode will achieve double or quadruple the transfer bandwidth for READ and PROGRAM operations.

QPI

The device supports Quad Peripheral Interface (QPI) operations only when the device is switched from Standard/Dual/Quad SPI mode to QPI mode using the enter QPI (35h) instruction. The typical SPI protocol requires that the byte-long instruction code being shifted into the device only via SI pin in eight serial clocks. The QPI mode utilizes all four I/O pins to input the instruction code thus requiring only two serial clocks. This can significantly reduce the SPI instruction overhead and improve system performance. Only QPI mode or SPI/Dual/Quad mode can be active at any given time. Enter QPI (35h) and Exit QPI (F5h) instructions are used to switch between these two modes, regardless of the non-volatile Quad Enable (QE) bit status in the Status Register. Power Reset or Hardware/Software Reset will return the device into the standard SPI mode. SI and SO pins become bidirectional I/O0 and I/O1, and WP# and HOLD# pins become I/O2 and I/O3 respectively during QPI mode.

DTR

In addition to SPI and QPI features, the device also supports Fast READ DTR operation, which allows high data throughput while running at lower clock frequencies. DTR READ mode uses both rising and falling edges of the clock to drive output, resulting in reducing input and output cycles by half.



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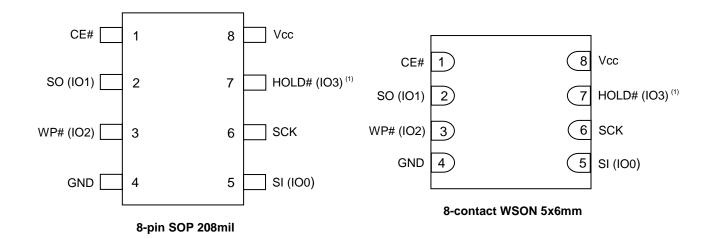




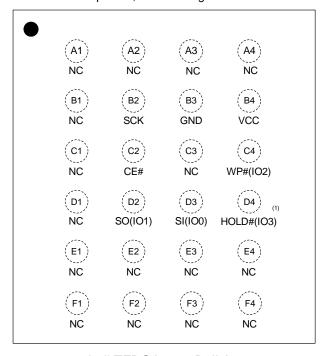
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1. PIN CONFIGURATION

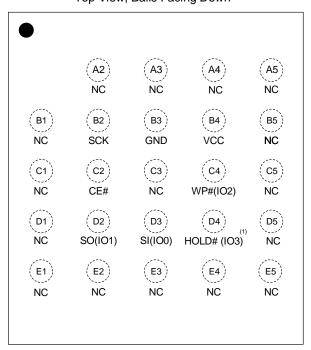


Top View, Balls Facing Down



24-ball TFBGA, 4x6 Ball Array

Top View, Balls Facing Down



24-ball TFBGA, 5x5 Ball Array

Note1: For RESET# pin option instead of HOLD# pin, call Factory.

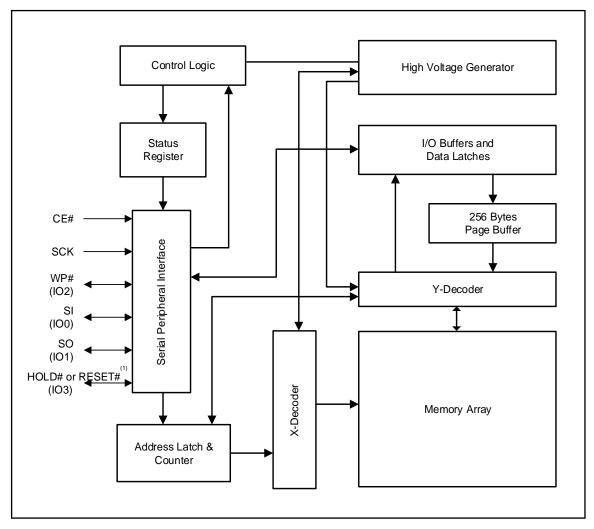


2. PIN DESCRIPTIONS

SYMBOL	TYPE	DESCRIPTION
		Chip Enable: The Chip Enable (CE#) pin enables and disables the devices operation. When CE# is high the device is deselected and output pins are in a high impedance state. When deselected the devices non-critical internal circuitry power down to allow minimal levels of power consumption while in a standby state.
CE#	INPUT	When CE# is pulled low the device will be selected and brought out of standby mode. The device is considered active and instructions can be written to, data read, and written to the device. After power-up, CE# must transition from high to low before a new instruction will be accepted.
		Keeping CE# in a high state deselects the device and switches it into its low power state. Data will not be accepted when CE# is high.
SI (IO0), SO (IO1)	INPUT/OUTPUT	Serial Data Input, Serial Output, and IOs (SI, SO, IO0, and IO1): This device supports standard SPI, Dual SPI, and Quad SPI operation. Standard SPI instructions use the unidirectional SI (Serial Input) pin to write instructions, addresses, or data to the device on the rising edge of the Serial Clock (SCK). Standard SPI also uses the unidirectional SO (Serial Output) to read data or status from the device on the falling edge of the serial clock (SCK).
		In Dual and Quad SPI mode, SI and SO become bidirectional IO pins to write instructions, addresses or data to the device on the rising edge of the Serial Clock (SCK) and read data or status from the device on the falling edge of SCK. Quad SPI instructions use the WP# and HOLD# pins as IO2 and IO3 respectively.
WP# (IO2)	INPUT/OUTPUT	Write Protect/Serial Data IO (IO2): The WP# pin protects the Status Register from being written in conjunction with the SRWD bit. When the SRWD is set to "1" and the WP# is pulled low, the Status Register bits (SRWD, QE, BP3, BP2, BP1, BP0) are write-protected and vice-versa for WP# high. When the SRWD is set to "0", the Status Register is not write-protected regardless of WP# state.
		When the QE bit is set to "1", the WP# pin (Write Protect) function is not available since this pin is used for IO2.
		HOLD# or RESET#/Serial Data IO (IO3): When the QE bit of Status Register is set to "1", HOLD# pin or RESET# is not available since it becomes IO3. When QE=0 the pin acts as HOLD# or RESET#.
		RESET# pin can be selected with dedicated parts (Call Factory).
HOLD# or RESET# (IO3)	INPUT/OUTPUT	The HOLD# pin allows the device to be paused while it is selected. It pauses serial communication by the master device without resetting the serial sequence. The HOLD# pin is active low. When HOLD# is in a low state and CE# is low, the SO pin will be at high impedance. Device operation can resume when HOLD# pin is brought to a high state.
		RESET# pin is a hardware RESET signal. When RESET# is driven HIGH, the memory is in the normal operating mode. When RESET# is driven LOW, the memory enters reset mode and output is High-Z. If RESET# is driven LOW while an internal WRITE, PROGRAM, or ERASE operation is in progress, data may be lost.
SCK	INPUT	Serial Data Clock: Synchronized Clock for input and output timing operations.
Vcc	POWER	Power: Device Core Power Supply
GND	GROUND	Ground: Connect to ground when referenced to Vcc
NC	Unused	NC: Pins labeled "NC" stand for "No Connect" and should be left uncommitted.



3. BLOCK DIAGRAM



Note1: For RESET# pin option instead of HOLD# pin, call Factory.



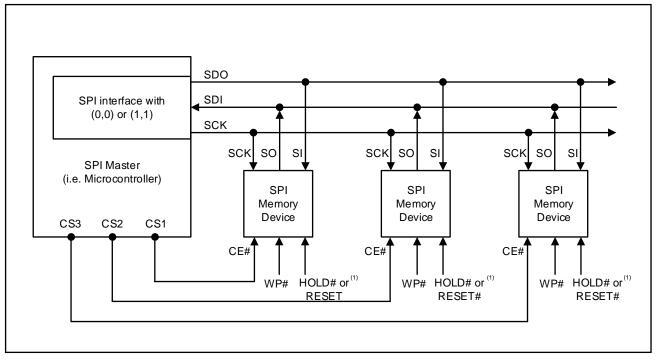
4. SPI MODES DESCRIPTION

Multiple XM25QH128B devices can be connected on the SPI serial bus and controlled by a SPI Master, i.e. microcontroller, as shown in Figure 4.1. The devices support either of two SPI modes:

Mode 0 (0, 0) Mode 3 (1, 1)

The difference between these two modes is the clock polarity. When the SPI master is in stand-by mode, the serial clock remains at "0" (SCK = 0) for Mode 0 and the clock remains at "1" (SCK = 1) for Mode 3. Please refer to Figure 4.2 and Figure 4.3 for SPI and QPI mode. In both modes, the input data is latched on the rising edge of Serial Clock (SCK), and the output data is available from the falling edge of SCK.

Figure 4.1 Connection Diagram among SPI Master and SPI Slaves (Memory Devices)



Notes:

- 1. For RESET# pin option instead of HOLD# pin, call Factory.
- 2. SI and SO pins become bidirectional IO0 and IO1, and WP# and HOLD# pins become IO2 and IO3 respectively during QPI mode.



Figure 4.2 SPI Mode Support

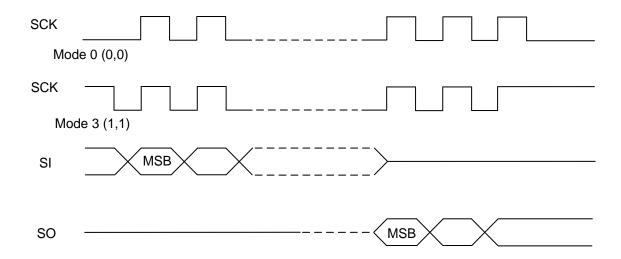
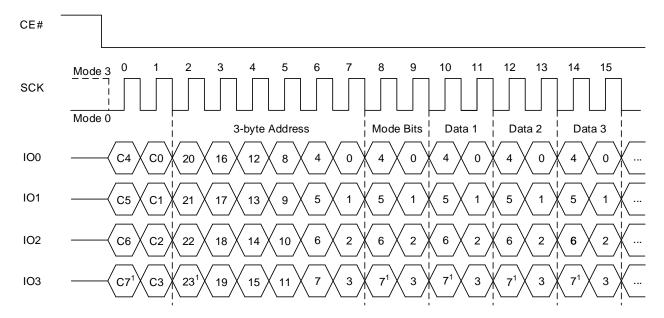


Figure 4.3 QPI Mode Support



Note1: MSB (Most Significant Bit)

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5. SYSTEM CONFIGURATION

The memory array is divided into uniform 4 Kbyte sectors or uniform 32/64 Kbyte blocks (a block consists of eight/sixteen adjacent sectors respectively).

Table 5.1 illustrates the memory map of the device. The Status Register controls how the memory is protected.

5.1 BLOCK/SECTOR ADDRESSES

Table 5.1 Block/Sector Addresses of XM25QH128B

Memory Density	Block No. (64Kbyte)	Block No. (32Kbyte)	Sector No.	Sector Size (Kbyte)	Address Range
		Block 0	Sector 0	4	000000h – 000FFFh
	Diagle 0		:	:	:
	Block 0	Dioak 1	:	:	:
		Block 1	Sector 15	4	00F000h - 00FFFFh
		Block 2	Sector 16	4	010000h – 010FFFh
	Block 1	DIOCK 2	:	••	:
	DIOCK I	Block 3	:	••	:
		DIOCK 3	Sector 31	4	01F000h - 01FFFFh
		Block 4	Sector 32	4	020000h – 020FFFh
	Block 2	DIOCK 4	:	••	:
	DIUCK 2	Block 5	:	••	:
		DIOCK 5	Sector 47	4	02F000h - 02FFFFh
	:	:	:	:	:
	Block 63	Block 126	Sector 1008	4	3F0000h – 3F0FFFh
			:	:	:
128Mb		Block 127	:	:	:
			Sector 1023	4	3FF000h – 3FFFFFh
	:	:	:	:	:
	Block 127	Block 254	Sector 2032	4	7F0000h – 7F0FFFh
			:	:	:
		Block 255	:	:	:
			Sector 2047	4	7FF000h – 7FFFFFh
	:	:	:	:	:
			Sector 4064	4	FE0000h – FE0FFFh
		Block 508	:	:	:
	Block 254	-	:	:	:
		Block 509	Sector 4079	4	FEF000h – FEFFFFh
		Di1 540	Sector 4080	4	FF0000h – FF0FFFh
	Disal Off	Block 510	:	:	:
	Block 255	Disab 544	:	:	:
		Block 511	Sector 4095	4	FFF000h – FFFFFFh



5.2 SERIAL FLASH DISCOVERABLE PARAMETERS

The Serial Flash Discoverable Parameters (SFDP) standard defines the structure of the SFDP database within the memory device. SFDP is the standard of JEDEC JESD216.

The JEDEC-defined header with Parameter ID FF00h and related Basic Parameter Table is mandatory. Additional parameter headers and tables are optional.

Table 5.2 Signature and Parameter Identification Data Values

Table 3.2 Sign	ature anu	Parameter identification	i Dala Values
Address (Byte)	Address (Bit)	Data	Description
00h	7:0	53h	
01h	15:8	46h	
02h	23:16	44h	SFDP Signature
03h	31:24	50h	
04h	7:0	06h	SFDP Major Revision Number
05h	15:8	01h	SFDP Major Revision Number
06h	23:16	01h	Number of Parameter Headers (NPH)
07h	31:24	FFh	Unused
08h	7:0	00h	Parameter ID LSB: JEDEC ID
09h	15:8	06h	Parameter Table Major Revision Number
0Ah	23:16	01h	Parameter Table Major Revision Number
0Bh	31:24	10h	Parameter Length
0Ch	7:0	30h	
0Dh	15:8	00h	JEDEC Parameter Table Pointer (PTP)
0Eh	23:16	00h	
0Fh	31:24	FFh	Parameter ID MSB: JEDEC ID
10h	7:0	9Dh	Parameter
11h	15:8	05h	Parameter Table Minor Revision Number
12h	23:16	01h	Parameter Table Major Revision Number
13h	31:24	03h	Parameter Length
14h	7:0	80h	
15h	15:8	00h	Parameter Table Pointer (PTP)
16h	23:16	00h	
17h	31:24	02h	Bank Number of Manufacturer ID
			Block/Sector Erase Sizes
	1:0		00=Reserved 01=4KB Erase 10=Reserved
			11=not support 4K Erase
	_		Write Granularity
	2		0:1Byte, 1:64Byte or larger
30h		E5h	Volatile Status Register Block Protect bits 0: Non-volatile
	3		1 : Volatile
	3		
			Write Enable Opcode Select for writing to
			Volatile Status Register
	4		0 : use 50h opcode 1 : use 06h opcode
	4		I . use our opcode



			AMZJ
	7:5		Unused
31h	15:8	20h	Sector Erase OP Code (4KB)
	16		(1-1-2) Fast Read – Dual Output 0=not supported 1=supported
	18:17		00=3Byte only, 01=3 or 4Byte, 10=4Byte only, 11=Reserved
224	19	FOL	Double Transfer Rate (DTR) Clocking 0=not supported 1=supported
32h	20	F9h	(1-2-2) Fast Read – Dual I/O 0=not supported 1=supported
	21		(1-4-4) Fast Read – Quad I/O 0=not supported 1=supported
	22		(1-1-4) Fast Read – Quad Output 0=not supported1=supported
	23		Unused
33h	31:24	FFh	Unused
37h:34h	31:0	see Description	256Mb= 0FFFFFFFh, 128Mb= 07FFFFFFh, 64Mb= 03FFFFFFh,32Mb= 01FFFFFh, 16Mb= 00FFFFFFh,8Mb= 007FFFFFh, 4Mb= 003FFFFFh,2Mb= 001FFFFFh
	4:0		(1-4-4) Fast Read Number of Dummy Cycles 0 0000b : Dummy cycles not supported
38h	7:5	44h	(1-4-4) Fast Read Number of Mode Cycles 000b : Mode Bits not support
39h	15:8	EBh	(1-4-4) Fast Read Opcode – Quad I/O
3Ah	20:16	00h	(1-1-4) Fast Read Number of Dummy Cycles 0 0000b : Dummy cycles not support
SAII	23:21	08h 23:21	(1-1-4) Fast Read Number of Mode Cycles 000b : Mode Bits not support
3Bh	31:24	6Bh	(1-1-4) Fast Read Opcode – Quad Output
3Ch	4:0	08h	(1-1-2) Fast Read Number of Dummy Cycles 0 0000b : Dummy cycles not support
3011	7:5	0011	(1-1-2) Fast Read Number of Mode Cycles 000b : Mode Bits not support
3Dh	15:8	3Bh	(1-1-2) Fast Read Opcode – Dual Output
3Eh	20:16	80h	(1-2-2)Fast Read Number of Dummy Cycles 0 0000b : Dummy cycles not support
) SEII	23:21	OUII	(1-2-2) Fast Read Number of Mode Cycles 000b : Mode Bits not support
3Fh	31:24	BBh	(1-2-2) Fast Read Opcode – Dual I/O
40h	0	FEh	Fast Read – Dual I/O QPI 0=not supported 1=supported
	3:1		Reserved



	l		(4-4-4) Fast Read – Quad I/O QPI 0=not
			supported
	4		1=supported
	7:5		Reserved
41h	15:8	FFh	Reserved
42h	23:16	FFh	Reserved
43h	31:24	FFh	Reserved
44h	7:0	FFh	Reserved
45h	15:8	FFh	Reserved
			(2-2-2) Fast Read Number of Dummy Cycles 0
	20:16		0000b : Dummy cycles not support
46h		00h	(2-2-2) Fast Read Number of Mode Cycles
	23:21		000b : Mode Bits not support
47h	31:24	FFh	(2-2-2) Fast Read Opcode – Dual I/O QPI
48h	7:0	FFh	Reserved
49h	15:8	FFh	Reserved
	20.15		4-4-4) Fast Read Number of Dummy Cycles
	20:16		0 0000b : Dummy cycles not support
4Ah	23:21	44H	(4-4-4) Fast Read Number of Mode Cycles
			000b : Mode Bits not support
4Bh	31:24	EBh	(4-4-4) Fast Read Opcode – Quad I/O QPI
4Ch	7:0	0Ch	Sector Type (Erase Type) 1 Size
4Dh	15:8	20h	0000 Sector Type (Erase Type) 1 Opcode
4Eh	23:16	Ofh	Sector Type (Erase Type) 2 Size
4Fh	31:24	52h	Sector Type (Erase Type) 2 Opcode
50h	7:0	10h	Sector Type (Erase Type) 3 Size
51h	15:8	D8H	Sector Type (Erase Type) 3 Opcode
52h	23:16	00h	Sector Type (Erase Type) 4 Size
53h	31:24	FFh	Sector Type (Erase Type) 4 Opcode
			Multiplier from typical erase time to maximum
			erase time (3:0 count)
			- Formula: EraseType n (or Chip) erase
			maximum time = 2*(count +
			1)*EraseType n (or Chip) erase typical time
EAL EEL ECL			NOTE: This multiplier applies to all erase types
54h 55h 56h	3:0	23h 4Ah C9h 00h	and the chip erase. The
57h			maximum time is intended to be used as a watchdog timeout for an error or
			failure condition. Since a common scale factor
			is used across all erase sizes,
			any particular maximum time may only
			approximate the datasheet maximum
			time.





			7111200
	8:4 10:9		Erase Type 1 Erase, Typical time (10:9 units, 8:4 count) This field has no meaning if the corresponding Erase Type size is 00h Formula: typical time = (count + 1)*units
	15:11 17:6		Erase Type 2 Erase, Typical time (17:16 units, 15:11 count) This field has no meaning if the corresponding Erase Type size is 00h. - Formula: typical time = (count + 1)*units
	22:18 24:23		Erase Type 3 Erase, Typical time (24:23 units, 22:18 count) This field has no meaning if the corresponding Erase Type size is 00h Formula: typical time = (count + 1)*units
	29:25 31:30		Erase Type 4 Erase, Typical time (31:30 units, 29:25 count) This field has no meaning if the corresponding Erase Type size is 00h Formula: typical time = (count + 1)*units
	3:0		Multiplier from typical time to max time for Page or byte program (3:0 count) 40 < 2*(2+1)*8 Formula: maximum time = 2*(count + 1)*typical time NOTE This multiplier applies to all page or byte typical program times. The maximum time is intended to be used as a watchdog timeout for an error or failure condition.
	7:4		Page SizeThis field specifies 'N'. (page size =
58h 59h 5Ah	82h D8h 11h 12:8 13	2^N bytes) Page Program Typical time 13 units, 12:8 count Time the device typically takes to write a full page. The user may scale this by ½ or ¼ to determine approximate times for ½ and ¼ page program operations. Formula: typical page program time = (count + 1)*units	
			Byte Program Typical time, first byte (18 units, 17:14 count) Time the device typically takes to write the first byte in a sequence Formula: first byte typical time = (count + 1)*units





			AMZJG
	22:19 23		Byte Program Typical time, additional byte (23 units, 22:19 count) Time the device typically takes to write each additional byte after the first. - Formula: additional byte time = (count + 1)*units/byte NOTE The programming time for small numbers of bytes does not scale linearly up to a full page programming time. When the number of bytes being programmed exceeds ½ of a page size, users should base estimates on the Page Program typical time in this DWORD.
5Bh	28:24 30:29		Chip Erase, Typical time (30:29 units, 28:24 count) Typical time to erase one chip (die). For a device consisting of multiple die, that are individually accessed, the time is for each die to which a chip erase command is applied. This field has no meaning if the corresponding Erase Type size is 00h. Typical time to erase one chip (die). For a device consisting of multiple die, that are individually accessed, the time is for each die to which a chip erase command is applied. This field has no meaning if the corresponding Erase Type size is 00h.
	31	1	Reserved
5Ch	3:0	CCh	Prohibited Operations During Program Suspend xxx0b: May not initiate a new erase anywhere (erase nesting not permitted) xxx1b: May not initiate a new erase in the program suspended page size xx0xb: May not initiate a new page program anywhere (program nesting not permitted) xx1xb: May not initiate a new page program in the program suspended page size x0xxb: Refer to vendor datasheet for read restrictions x1xxb: May not initiate a read in the program suspended page size



			Oxxxb: Additional erase or program restrictions apply 1xxxb: The erase and program restrictions in bits 1:0 are sufficient
	7:4		Prohibited Operations During Erase Suspend xxx0b: May not initiate a new erase anywhere (erase nesting not permitted) xxx1b: May not initiate a new erase in the erase suspended erase type size xx0xb: May not initiate a page program anywhere xx1xb: May not initiate a page program in the erase suspended erase type size x0xxb: Refer to vendor datasheet for read restrictions x1xxb: May not initiate a read in the erase suspended erase type size 0xxxb: Additional erase or program restrictions apply 1xxxb: The erase and program restrictions in bits 5:4 are sufficient
	8		Reserved
5Dh 5Eh	12:9	CDh 68h	Program Resume to Suspend Interval (12:9 count) count of fixed units of 64us - Formula: program resume to suspend interval = (count + 1)*units
	17:13 19:18	Suspend in-progress program max latency (19:18 units, 17:13 count) Formula: suspend in-progress program max latency =(count + 1)*units	





			720
	23:20 28:24 30:29		Erase Resume to Suspend Interval (23:20 count)count of fixed units of 64us - Formula: erase resume to suspend interval = (count +1)*64 us Suspend in-progress erase max latency (30:29 units, 28:24 count) Formula: erase max latency = (count +
5Fh		46h	1)*units
	31		Suspend / Resume supported 0: supported 1: not supported
60h		7Ah	Program Resume Instruction
61h		75h	Program Suspend Instruction
62h		7Ah	Resume Instruction
63h		75h	Suspend Instruction
	7:2		Reserved Status Register Polling Device Busy 1x_xxxxb: Reserved x1_xxxxb: Reserved xx_1xxxb: Reserved xx_x1xxb: Reserved xx_xx1xb: By reading the Flag Status Register with 70hinstruction and checking bit[7](0=busy; 1=ready)xx_xxx1b: Use of legacy polling is supported by reading the Status Register with 05hinstruction and checking WIP bit[0](0=ready; 1=busy). Exit Deep Power-down to next operation delay
64h 65h 66h 67h	I F7h Δ2h D5h 5	F7h A2h D5h 5Ch	(14:13 units, 12:8 count) time required by the flash device to exit Deep Power-down and be ready to accept any command. (Note: Read status is not valid when exiting Deep Power-down.) - Formula: exit Deep Power-down to next operation delay = (count +1)*units
	22:15		Exit Deep Power-down Instruction
	30:23		Enter Deep Power-down Instruction
	31		Deep Power-down Supported 0: supported 1: not supported
i	1	1	





			AMIZJO
	3:0	4Ah 42h	4-4-4 mode disable sequences (QIODI) xxx1b: issue FFh instruction xx1xb: issue F5h instruction x1xxb: device uses a read-modify-write sequence of operations: Using read instruction 65h and write instruction 71h. 1xxxb: issue the Soft Reset 66/99 sequence
68h 69h	8:4		4-4-4 mode enable sequences (QIOEN) x_xxx1b: set QE per QER description below, then issue instruction 38h x_xx1xb: issue instruction 38h x_x1xxb: issue instruction 35h x_1xxxb: device uses a read-modify-write sequence of operations: Using read instruction 65h and write instruction 71h. 1_xxxxb:4-4-4 mode enable/disable sequences Device uses a read-modify-write sequence of operations: Using read instruction 65h and write instruction 61h
	9		0-4-4 mode supported 0: not supported 1: supported
	15:10		0-4-4 Mode Exit Method: xx_xxx1b: Mode Bits[7:0] = 00h xx_xx1xb: Input Fh (8 clocks: 3-byte address mode, 10 15:10 0100 00 clocks: 4-byte address mode) xx_x1xxb: Reserved xx_1xxxb: Input Fh (mode bit reset) for 8 clocks. x1_xxxxb: Mode Bit[7:0] ≠ Axh 1x_xxxxb: Reserved
	19:16		0-4-4 Mode Entry Method: xxx1b: Mode Bits[7:0] = A5h xx1xb: Mode Bits [7:0] = 01h x1xxb: Mode Bit[7:0]=AXh 1xxxb: Reserved
6Ah 6Bh	22:20	2Ch FFh	Quad Enable Requirements (QER): 000b: Device does not have a QE bit. 001b: QE is bit 1 of Status Register 2. 010b: QE is bit 6 of Status Register 1. It is set via Write Status with one data byte where bit 6 is one. It is cleared via Write Status with one data byte where bit





			6 is zero. 011b: QE is bit 7 of Status Register 2. 100b: QE is bit 1 of Status Register 2. 101b: QE is bit 1 of Status Register 2. other: reserved
	23		HOLD or RESET Disable If driving DQ3 high during command phase HOLD or RESET do not need to be disabled. Device decodes instruction to determine functionality of HOLD/RESET vs. data 1: set bit 4 of the Non-Volatile Extended Configuration Register = 0 to disable HOLD or RESET 0: above feature is not supported
	31:24		Reserved
6Ch	6:0	F0h	Volatile or Non-Volatile Register and Write Enable (WREN) Instruction for Status Register 1 xxx_xxx1b: Non-Volatile Status Register 1, WREN: 06h xxx_xx1xb: Volatile Status Register 1, WREN: 06h xxx_x1xxb: Volatile Status Register 1, WREN: 50h xxx_1xxxb: Non-Volatile/Volatile Status Register 1, WREN for Non-Volatile Status Register: 06h WREN for Volatile Status Register: 50h xx1_xxxxb: Status Register 1 contains a mix of volatile and non-volatile bits. WREN: 06h x1x xxxxb: Reserved 1xx xxxxb: Reserved
	7		Reserved





			AIVIZOG
			Soft Reset and Rescue Sequence Support
			00_0000b: no software reset instruction is
			supported
			xx_xxx1b: drive Fh on all 4 IOs for 8 clocks
			xx_xx1xb: drive Fh on all 4 IOs for 10 clocks if
			device I
			operating in 4-byte address mode xx_x1xxb:
			drive Fh on all 4 IOs for 16 clocks
	13:8		xx_1xxxb: issue instruction F0h
	13.0		x1_xxxxb: issue reset enable instruction 66h,
			then issue reset instruction 99h. The reset
			enable, reset sequence may be issued on 1, 2,
			or
			4 IOs depending on the device operating
			mode.
			1x_xxxxb: exit 0-4-4 mode is required prior to
			other reset sequences above if the device may
			be operating in this mode.
			Exit 4-Byte Addressing
			xx_xxxx_xxx1b: E9h (preceding WREN not
			required) xx_xxxx_xx1xb: E9h
			(preceding WREN required) xx_xxxx_x1xxb: 8-
		30h	bit volatile extended address
6Dh			register used to define A[31:24]
6Eh		C0h	bits. Read with instruction C8h.
			Write instruction is C5h, data
			length is 1 byte. Return to lowest memory
			segment by setting
			xx_xxxx_1xxxb: 8-bit volatile bank
			register used to define A[30:A24]
			bits. MSB (bit[7]) is used to
			enable/disable 4-byte address
	23:14		mode. When MSB is cleared to '0',
			3- byte address mode is active and
			128 Mbit memory segment. Read
			with instruction 16h. Write
			instruction is 17h, data length is 1
			xx_xxx1_xxxxb: A 16-bit nonvolatile
			configuration register controls 3-
			byte/4-byte address mode. Read
			instruction is B5h. Bit[0] controls
			address mode [0=3-byte; 1=4-
			byte]. Write configuration register
			xx_xx1x_xxxxb: Hardware Reset (HWR)
			xx_x1xx_xxxxb: Software Reset
			xx_1xxx_xxxxb: Power cycle x1_xxxx_xxxxb:
			Reserved 1x_xxxx_xxxxb:
			Reserved
			·



6Fh	31:24	80h for 128M and below	Enter 4-Byte Addressing xxxx_xxx1b: B7h (preceding WREN not required) xxxx_xx1xb: B7h (preceding WREN required) xxxx_x1xxb: 8-bit volatile extended address register used to define A[31:24] bits. Read with instruction C8h. Write instruction is C5h with 1 byte of data. Select the active 128Mbit memory segment by setting the appropriate [31:24] bits and use 3-byte addressing. xxxx_1xxxb: 8-bit volatile bank register used to define A[30:A24] bits. MSB (bit[7]) is used to enable/disable 4-byte address mode. When MSB is set to '1', 4-byte address mode is active and A[30:24] bits are don't care. Read with instruction 16h. Write instruction is 17h with 1 byte of data. When MSB is cleared to '0', select the active 128 Mbit xxx1_xxxxb: A 16-bit nonvolatile configuration register controls 3-byte/4-byte address mode. Read instruction is B5h. Bit[0] controls address mode [0=3-byte; 1=4-byte]. Write configuration register instruction is B1h, data length is 2 bytes. xx1x_xxxxb: Supports dedicated 4-byte address instruction set. Consult the corresponding product's data sheet for the instruction set definition. x1xx_xxxxb: Always operates in 4-byte address mode 1xxx_xxxxb: Reserved
			Vcc Supply Maximum Voltage 1950h = 1.95V
81h:80h		3600h	2000h = 2.00V
		1950h	2700h = 2.70V 3600h = 3.60V
83h:82h		2300h 1650h	Vcc Supply Minimum Voltage 1650h = 1.65V 2300h = 2.30V 2700h = 2.70V



		F99Dh for the products with RESET# option F99Eh for the products with HOLD# option F99Fh for the products	Bit[0]: HW Reset# Pin 0=not supported 1=supported Bit[1]: HW Hold# Pin 0=not supported 1=supported Bit[2]: Deep Power Down Mode 0=not supported 1=supported Bit[3]: SW Reset 0=not supported 1=supported Bit[11:04]: SW Reset Opcode: 99h Bit[11:04]: SW Reset Opcode: 99h 1=supported Bit[12]: Program Suspend / Resume 0=not supported 1=supported Bit[13]: Erase Suspend / Resume 0=not supported 1=supported Bit[14]: Reserved
		with additional	Bit[15]: Wrap-Around Read Mode 0=not
		RESET# option (16P	supported
85h:84h		SOIC 300mil package)	1=supported
86h		C0h	Wrap-Around Read Mode Opcode
87h		64h	Wrap-Around Read data length 08h=support 8B 16h=support 8B & 16B 32h=support 8B & 16B & 32B & 64h=support 8B & 16B & 32B & 64B
0711		EC8Fh for 128M and	Bit[0]: Individual Block Lock 0=not supported SFGD for 128M and 1=supported Bit[1]: Individual Block Lock bit 0: Volatile 1: Non-volatile Bit[09:02]: Individual Block Lock Opcode 23h for 128M and below E3h for 256M Bit[10]: Individual Block Lock bit default protect status 0=protect 1=unprotect Bit[11]: Secured Programmable Area 0=not supported 1=supported Bit[12]: Read Lock 0=not supported 1=supported Bit[13]: Permanent Lock 0=not supported 1=supported
89h:88h		below	Bit[15:14] : Reserved
8Ah	FFh		Reserved





8Bh	FFh		Reserved
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6. REGISTERS

The device has three sets of Registers: Status, Function and Read.

When the register is read continuously, the same byte is output repeatedly until CE# goes HIGH.

6.1 STATUS REGISTER

Status Register Format and Status Register Bit Definitions are described in Tables 6.1 & 6.2.

Table 6.1 Status Register Format

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
	SRWD	QE	BP3	BP2	BP1	BP0	WEL	WIP
Default	0	Note1	0	0	0	0	0	0

Note1: The default value of QE bit depends on different Order Part Number, please check detail information in ORDERING INFORMATION.

Table 6.2 Status Register Bit Definition

Bit	Name	Definition	Read- /Write	Туре
Bit 0	WIP	Write In Progress Bit: "0" indicates the device is ready(default) "1" indicates a write cycle is in progress and the device is busy	R	Volatile
Bit 1	WEL	Write Enable Latch: "0" indicates the device is not write enabled (default) "1" indicates the device is write enabled	R/W ¹	Volatile
Bit 2	BP0			
Bit 3	BP1	Block Protection Bit: (See Tables 6.4 for details)	DAA	Nia a Valadia
Bit 4	BP2	"0" indicates the specific blocks are not write-protected (default) "1" indicates the specific blocks are write-protected	R/W	Non-Volatile
Bit 5	BP3			
Bit 6	QE	Quad Enable bit: "0" indicates the Quad output function disable "1" indicates the Quad output function enable	R/W	Non-Volatile
Bit 7	SRWD	Status Register Write Disable: (See Table 7.1 for details) "0" indicates the Status Register is not write-protected (default) "1" indicates the Status Register is write-protected	R/W	Non-Volatile

Note1: WEL bit can be written by WREN and WRDI commands, but cannot by WRSR command.

The BP0, BP1, BP2, BP3, QE, and SRWD are non-volatile memory cells that can be written by a Write Status Register (WRSR) instruction. The default value of the BP0, BP1, BP2, BP3 and SRWD bits were set to "0" at factory. The Status Register can be read by the Read Status Register (RDSR).

The function of Status Register bits are described as follows:

WIP bit: The Write In Progress (WIP) bit is read-only, and can be used to detect the progress or completion of a program or erase operation. When the WIP bit is "0", the device is ready for Write Status Register, program or erase operation. When the WIP bit is "1", the device is busy.

WEL bit: The Write Enable Latch (WEL) bit indicates the status of the internal write enable latch. When the WEL is "0", the write enable latch is disabled and the write operations described in Table 6.3 are inhibited. When the WEL bit is "1", the write operations are allowed. The WEL bit is set by a Write Enable (WREN) instruction.





Each write register, program and erase instruction except for Set volatile Read Register must be preceded by a WREN instruction. The WEL bit can be reset by a Write Disable (WRDI) instruction. It will automatically reset after the completion of any write operation.



Table 6.3 Instructions requiring WREN instruction ahead

	Instructions must be preceded by the WREN instruction						
Name	Hex Code	Operation					
PP	02h	Serial Input Page Program					
PPQ	32h/38h	Quad Input Page Program					
SER	D7h/20h	Sector Erase					
BER32 (32KB)	52h	Block Erase 32KB					
BER64 (64KB)	D8h	Block Erase 64KB					
CER	C7h/60h	Chip Erase					
WRSR	01h	Write Status Register					
WRFR	42h	Write Function Register					
IRER	64h	Erase Information Row					
IRP	62h	Program Information Row					

BP3, **BP2**, **BP1**, **BP0** bits: The Block Protection (BP3, BP2, BP1 and BP0) bits are used to define the portion of the memory area to be protected. Refer to Tables 6.4 for the Block Write Protection (BP) bit settings. When a defined combination of BP3, BP2, BP1 and BP0 bits are set, the corresponding memory area is protected. Any program or erase operation to that area will be inhibited.

Note: A Chip Erase (CER) instruction will be ignored unless all the Block Protection Bits are "0"s.

SRWD bit: The Status Register Write Disable (SRWD) bit operates in conjunction with the Write Protection (WP#) signal to provide a Hardware Protection Mode. When the SRWD is set to "0", the Status Register is not write-protected. When the SRWD is set to "1" and the WP# is pulled low (V_{IL}), the bits of Status Register (SRWD, QE, BP3, BP2, BP1, BP0) become read-only, and a WRSR instruction will be ignored. If the SRWD is set to "1" and WP# is pulled high (V_{IH}), the Status Register can be changed by a WRSR instruction.

QE bit: The Quad Enable (QE) is a non-volatile bit in the status register that allows quad operation. When the QE bit is set to "0", the pin WP# and HOLD# are enabled. When the QE bit is set to "1", the IO2 and IO3 pins are enabled.

WARNING: The QE bit must be set to 0 if WP# or HOLD# pin is tied directly to the power supply.





Table 6.4 Block (64Kbyte) assignment by Block Write Protect (BP) Bits

Status Register Bits			its	Protected Memory Area (XM25QH128B, 256Blocks)			
BP3	BP2	BP1	BP0	TBS(T/B selection) = 0, Top area	TBS(T/B selection) = 1, Bottom area		
0	0	0	0	0(None)	0(None)		
0	0	0	1	1(1 block : 255th)	1(1 block : 0th)		
0	0	1	0	2(2 blocks : 254th and 255th)	2(2 blocks : 0th and 1st)		
0	0	1	1	3(4 blocks : 252nd to 255th)	3(4 blocks : 0th to 3rd)		
0	1	0	0	4(8 blocks : 248th to 255th)	4(8 blocks : 0th to 7th)		
0	1	0	1	5(16 blocks : 240th to 255th)	5(16 blocks : 0th to 15th)		
0	1	1	0	6(32 blocks : 224th to 255th)	6(32 blocks : 0th to 31st)		
0	1	1	1	7(64 blocks : 192nd to 255th)	7(64 blocks : 0th to 63rd)		
1	0	0	0	8(128 blocks : 128th to 255th)	8(128 blocks : 0th to 127th)		
1	0	0	1	9(256 blocks : 0th to 255th) All blocks	9(256 blocks : 0th to 255th) All blocks		
1	0	1	Х	10-11(256 blocks : 0th to 255th) All blocks	10-11(256 blocks : 0th to 255th) All blocks		
1	1	Х	Х	12-15(256 blocks : 0th to 255th) All blocks	12-15(256 blocks : 0th to 255th) All blocks		

Note: x is don't care



6.2 FUNCTION REGISTER

Function Register Format and Bit definition are described in Table 6.5 and Table 6.6

Table 6.5 Function Register Format

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
	IRL3	IRL2	IRL1	IRL0	ESUS	PSUS	TBS	Reserved
Default	0	0	0	0	0	0	0	0

Table 6.6 Function Register Bit Definition

Bit	Name	Definition	Read- /Write	Туре
Bit 0	Reserved	Reserved	R	Reserved
Bit 1	Top/Bottom Selection	Top/Bottom Selection. (See Tables 6.4 for details) "0" indicates Top area. "1" indicates Bottom area.	R/W	ОТР
Bit 2	PSUS	Program suspend bit: "0" indicates program is not suspend "1" indicates program is suspend	R	Volatile
Bit 3	ESUS	Erase suspend bit: "0" indicates Erase is not suspend "1" indicates Erase is suspend	R	Volatile
Bit 4	IR Lock 0	Lock the Information Row 0: "0" indicates the Information Row can be programmed "1" indicates the Information Row cannot be programmed	R/W	ОТР
Bit 5	IR Lock 1	Lock the Information Row 1: "0" indicates the Information Row can be programmed "1" indicates the Information Row cannot be programmed	R/W	ОТР
Bit 6	IR Lock 2	Lock the Information Row 2: "0" indicates the Information Row can be programmed "1" indicates the Information Row cannot be programmed	R/W	ОТР
Bit 7	IR Lock 3	Lock the Information Row 3: "0" indicates the Information Row can be programmed "1" indicates the Information Row cannot be programmed	R/W	ОТР

Note: Function Register bits are only one time programmable and cannot be modified once set to "1".

Top/Bottom Selection: BP0~3 area assignment can be changed from Top (default) to Bottom by setting TBS bit to "1". However, once Bottom is selected, it cannot be changed back to Top since TBS bit is OTP. See Tables 6.4 for details.

PSUS bit: The Program Suspend Status bit indicates when a Program operation has been suspended. The PSUS changes to "1" after a suspend command is issued during the program operation. Once the suspended Program resumes, the PSUS bit is reset to "0".

ESUS bit: The Erase Suspend Status indicates when an Erase operation has been suspended. The ESUS bit is "1" after a suspend command is issued during an Erase operation. Once the suspended Erase resumes, the ESUS bit is reset to "0".

IR Lock bit 0 ~ 3: The Information Row Lock bits are programmable. If the bit set to "1", the Information Row can't be programmed.



6.3 READ REGISTERS

Read Register format and Bit definitions pertaining to QPI mode are described below.

READ PARAMETER BITS

Table 6.7 defines all bits that control features in SPI/QPI modes. The ODS2, ODS1, ODS0 (P7, P6, P5) bits provide a method to set and control driver strength. The Dummy Cycle bits (P4, P3) define how many dummy cycles are used during various READ modes. The wrap selection bits (P2, P1, P0) define burst length with wrap around.

The SET READ PARAMETERS Operation (SRP, C0h) is used to set all the Read Register bits, and can thereby define the output driver strength, number of dummy cycles used during READ modes, burst length with wrap around.

Table 6.7 Read Parameter Table

	P7	P6	P5	P4	P3	P2	P1	P0
	ODS2	ODS1	ODS0	Dummy Cycles	Dummy Cycles	Wrap Enable	Burst Length	Burst Length
Default (Volatile)	1	1	1	0	0	0	0	0

Table 6.8 Burst Length Data

	P1	P0
8 bytes	0	0
16 bytes	0	1
32 bytes	1	0
64 bytes	1	1

Table 6.9 Wrap Function

Wrap around boundary	P2
Whole array regardless of P1 and P0 value	0
Burst Length set by P1 and P0	1



Table 6.1 Table 6.10 Read Dummy Cycles vs Max Frequency

Read Modes	P4,P3 = 00 (Default)	P4,P3 = 01	P4,P3 = 10	P4,P3 = 11	Remark	Mode
Normal Read 03h	0	0	0	0	Max. 50MHz	SPI
Fast Read (2)	8	8	8	8	Max. 133MHz ⁽¹⁾	SPI
0Bh	6 (104MHz)	4 (84MHz)	8 ⁽¹⁾ (133MHz)	10 ⁽¹⁾ (133MHz)		QPI
Fast Read DTR	4	4	4	4	Max.66MHz	SPI
0Dh	3 (51MHz)	2 (38MHz)	4 (64MHz)	5 (66MHz)		QPI
Fast Read Dual Output 3Bh	8	8	8	8	Max. 133MHz ⁽¹⁾	SPI
Fast Read Dual IO BBh	4 (104MHz)	4 (104MHz)	8 ⁽¹⁾ (133MHz)	8 ⁽¹⁾ (133MHz)		SPI
Fast Read Dual IO DTR BDh	2 (52MHz)	2 (52MHz)	4 (66MHz)	4 (66MHz)		SPI
Fast Read Quad Output 6Bh	8	8	8	8	Max. 133MHz ⁽¹⁾	SPI
Fast Read Quad IO EBh	6 (104MHz)	4 (84MHz)	8 ⁽¹⁾ (133MHz)	10 ⁽¹⁾ (133MHz)		SPI , QPI
Fast Read Quad IO DTR EDh	3 (51MHz)	2 (38MHz)	4 (64MHz)	5 (66MHz)		SPI , QPI

Notes:

- 1. Max frequency is 133 MHz at Vcc=2.7V~3.6V and 104MHz at Vcc=2.3V~3.6V.
- 2. RDUID, RDSFDP, IRRD instructions are also applied.
- 3. In Fast Read DTR mode the dummy cycles are reduced by half.
- 4. Dummy cycles in the table are including Mode bit cycles.
- 5. Must satisfy bus I/O contention. For instance, if the number of dummy cycles and AX bit cycles are same, then X must be Hi-Z.

Table 6.11 Driver Strength Table

ODS2	ODS1	ODS0 Description		Remark
0	0	0	Reserved	
0	0	1	12.50%	
0	1	0	25%	
0	1	1 37.50%		
1	0	0	Reserved	
1	0	1 75%		
1	1	0 100%		
1	1	1	50%	Default



7. PROTECTION MODE

The device supports hardware and software write-protection mechanisms.

7.1 HARDWARE WRITE PROTECTION

The Write Protection (WP#) pin provides a hardware write protection method for BP3, BP2, BP1, BP0, SRWD, and QE in the Status Register. Refer to the section 6.1 STATUS REGISTER.

Write inhibit voltage (V_{WI}) is specified in the section 9.8 POWER-UP AND POWER-DOWN. All write sequence will be ignored when Vcc drops to V_{WI} .

Table 7.1 Hardware Write Protection on Status Register

SRWD	WP#	Status Register
0	Low	Writable
1	Low	Protected
0	High	Writable
1	High	Writable

Note: Before the execution of any program, erase or write Status/Function Register instruction, the Write Enable Latch (WEL) bit must be enabled by executing a Write Enable (WREN) instruction. If the WEL bit is not enabled, the program, erase or write register instruction will be ignored.

7.2 SOFTWARE WRITE PROTECTION

The device also provides a software write protection feature. The Block Protection (BP3, BP2, BP1, BP0) bits allow part or the whole memory area to be write-protected.



8. DEVICE OPERATION

The device utilizes an 8-bit instruction register. Refer to Table 8.1. Instruction Set for details on instructions and instruction codes. All instructions, addresses, and data are shifted in with the most significant bit (MSB) first_on Serial Data Input (SI) or Serial Data IOs (IO0, IO1, IO2, IO3). The input data on SI or IOs is latched on the rising edge of Serial Clock (SCK) for normal mode and both of rising and falling edges for DTR mode after Chip Enable (CE#) is driven low (V_{IL}). Every instruction sequence starts with a one-byte instruction code and is followed by address bytes, data bytes, or both address bytes and data bytes, depending on the type of instruction. CE# must be driven high (V_{IH}) after the last bit of the instruction sequence has been shifted in to end the operation.

Table 8.1 Instruction Set

Instruction Name	Operation	Mode	Byte0	Byte1	Byte2	Byte3	Byte4	Byte5	Byte6
NORD	Normal Read Mode	SPI	03h	A <23:16>	A <15:8>	A <7:0>	Data out		
FRD	Fast Read Mode	SPI QPI	0Bh	A <23:16>	A <15:8>	A <7:0>	Dummy ⁽¹⁾ Byte	Data out	
FRDIO	Fast Read Dual I/O	SPI	BBh	A <23:16> Dual	A <15:8> Dual	A <7:0> Dual	AXh ^{(1),(2)} Dual	Dual Data out	
FRDO	Fast Read Dual Output	SPI	3Bh	A <23:16>	A <15:8>	A <7:0>	Dummy ⁽¹⁾ Byte	Dual Data out	
FRQIO	Fast Read Quad I/O	SPI QPI	EBh	A <23:16> Quad	A <15:8> Quad	A <7:0> Quad	AXh ^{(1), (2)} Quad	Quad Data out	
FRQO	Fast Read Quad Output	SPI	6Bh	A <23:16>	A <15:8>	A <7:0>	Dummy ⁽¹⁾ Byte	Quad Data out	
FRDTR	Fast Read DTR Mode	SPI QPI	0Dh	A <23:16>	A <15:8>	A <7:0>	Dummy ⁽¹⁾ Byte	Dual Data out	
FRDDTR	Fast Read Dual I/O DTR	SPI	BDh	A <23:16> Dual	A <15:8> Dual	A <7:0> Dual	AXh ^{(1), (2)} Dual	Dual Data out	
FRQDTR	Fast Read Quad I/O DTR	SPI QPI	EDh	A <23:16>	A <15:8>	A <7:0>	AXh ^{(1), (2)} Quad	Quad Data out	
PP	Input Page Program	SPI QPI	02h	A <23:16>	A <15:8>	A <7:0>	PD (256byte)		
PPQ	Quad Input Page Program	SPI	32h 38h	A <23:16>	A <15:8>	A <7:0>	Quad PD (256byte)		
SER	Sector Erase	SPI QPI	D7h 20h	A <23:16>	A <15:8>	A <7:0>			
BER32 (32Kbyte)	Block Erase 32KB	SPI QPI	52h	A <23:16>	A <15:8>	A <7:0>			
BER64 (64Kbyte)	Block Erase 64KB	SPI QPI	D8h	A <23:16>	A <15:8>	A <7:0>			
CER	Chip Erase	SPI QPI	C7h 60h						
WREN	Write Enable	SPI QPI	06h						
WRDI	Write Disable	SPI QPI	04h						
RDSR ⁽⁵⁾	Read Status Register	SPI QPI	05h	SR					
WRSR	Write Status Register	SPI QPI	01h	WSR Data					
RDFR ⁽⁵⁾	Read Function Register	SPI QPI	48h	Data out					





Instruction Name	Operation	Mode	Byte0	Byte1	Byte2	Byte3	Byte4	Byte5	Byte6		
WRFR	Write Function Register	SPI QPI	42h	WFR Data							
QPIEN	Enter QPI mode	SPI	35h								
QPIDI	Exit QPI mode	QPI	F5h								
PERSUS	Suspend during program/erase	SPI QPI	75h B0h								
PERRSM	Resume program/erase	SPI QPI	7Ah 30h								
DP	Deep Power Down	SPI QPI	B9h								
RDID ⁽⁵⁾ , RDPD	Read ID / Release Power Down	SPI QPI	ABh	XXh ⁽³⁾	XXh ⁽³⁾	XXh ⁽³⁾	ID7-ID0				
SRP	Set Read Parameters	SPI QPI	C0h	Data in							
RDJDID ⁽⁵⁾	Read JEDEC ID Command	SPI QPI	9Fh	MF7-MF0	ID15-ID8	ID7-ID0					
RDMDID ⁽⁵⁾	Read Manufacturer	SPI	90h	90h	90h	XXh ⁽³⁾	XXh ⁽³⁾	00h	MF7-MF0	ID7-ID0	
TOMBIB	& Device ID	QPI		7041	7001	01h	ID7-ID0	MF7-MF0			
RDJDIDQ ⁽⁵⁾	Read JEDEC ID QPI mode	QPI	AFh	MF7-MF0	ID15-ID8	ID7-ID0					
RDUID	Read Unique ID	SPI QPI	4Bh	A ⁽⁴⁾ <23:16>	A ⁽⁴⁾ <15:8>	A ⁽⁴⁾ <7:0>	Dummy Byte	Data out			
RDSFDP	SFDP Read	SPI QPI	5Ah	A <23:16>	A <15:8>	A <7:0>	Dummy Byte	Data out			
RSTEN	Software Reset Enable	SPI QPI	66h								
RST	Software Reset	SPI QPI	99h								
IRER	Erase Information Row	SPI QPI	64h	A <23:16>	A <15:8>	A <7:0>					
IRP	Program Information Row	SPI QPI	62h	A <23:16>	A <15:8>	A <7:0>	PD (256byte)				
IRRD	Read Information Row	SPI QPI	68h	A <23:16>	A <15:8>	A <7:0>	Dummy Byte	Data out			
SECUN- LOCK	Sector Unlock	SPI QPI	26h	A <23:16>	A <15:8>	A <7:0>					
SECLOCK	Sector Lock	SPI QPI	24h								

- The number of dummy cycles depends on the value setting in the Table 6.10 Read Dummy Cycles.
 AXh has to be counted as a part of dummy cycles. X means "don't care".
- 3. XX means "don't care".
- 4. A<23:9> are "don't care" and A<8:4> are always "0".
- 5. The maximum clock frequency is 104MHz for Vcc=2.3V~2.7V and 133MHz for Vcc=2.7V~3.6V.



8.1 NORMAL READ OPERATION (NORD, 03h)

The NORMAL READ (NORD) instruction is used to read memory contents of the device at a maximum frequency of 50MHz.

The NORD instruction code is transmitted via the SI line, followed by three address bytes (A23 - A0) of the first memory location to be read. A total of 24 address bits are shifted in, but only A_{MSB} (most significant bit) - A_0 are decoded. The remaining bits (A23 – A_{MSB+1}) are ignored. The first byte addressed can be at any memory location. Upon completion, any data on the SI will be ignored. Refer to Table 8.2 for the related Address Key.

The first byte data (D7 - D0) is shifted out on the SO line, MSB first. A single byte of data, or up to the whole memory array, can be read out in one NORMAL READ instruction. The address is automatically incremented by one after each byte of data is shifted out. The read operation can be terminated at any time by driving CE# high (VIH) after the data comes out. When the highest address of the device is reached, the address counter will roll over to the 000000h address, allowing the entire memory to be read in one continuous READ instruction.

If the NORMAL READ instruction is issued while an Erase, Program or Write operation is in process (WIP=1) the instruction is ignored and will not have any effects on the current operation.

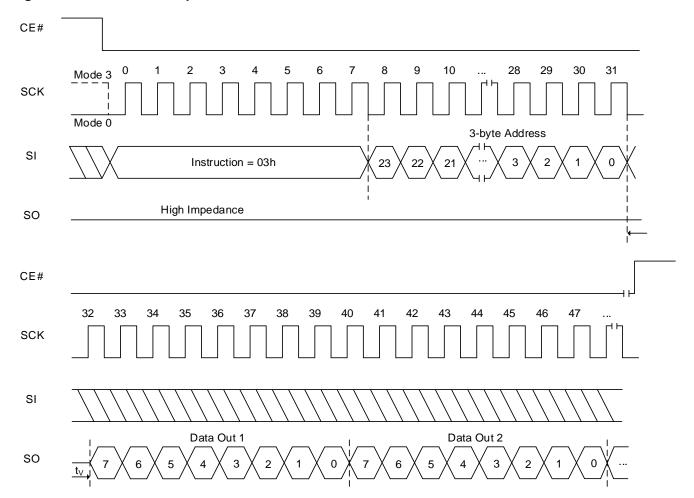
Table 8.2 Address Key

Address	XM25QH128B		
$A_{MSB} - A_0$	A23 - A0		

Note: X=Don't Care



Figure 8.1 Normal Read Sequence





8.2 FAST READ OPERATION (FRD, 0Bh)

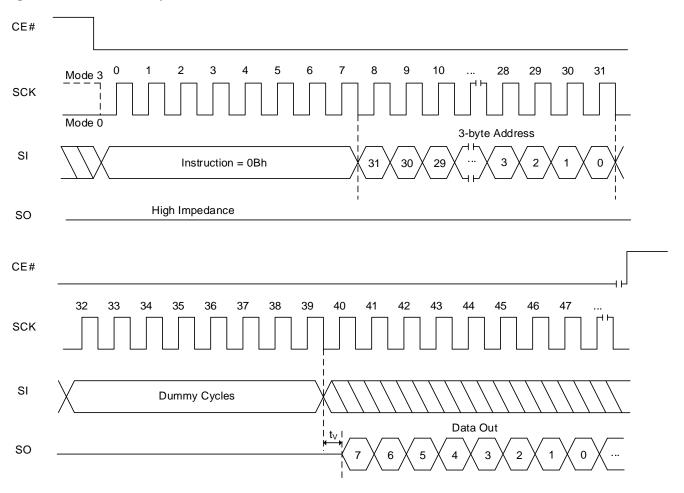
The FAST READ (FRD) instruction is used to read memory data at up to a 133MHz clock.

The FAST READ instruction code is followed by three address bytes (A23 - A0) and a dummy byte (8 clocks), transmitted via the SI line, with each bit latched-in during the rising edge of SCK. Then the first data byte from the address is shifted out on the SO line, with each bit shifted out at a maximum frequency f_{CT} , during the falling edge of SCK.

The first byte addressed can be at any memory location. The address is automatically incremented by one after each byte of data is shifted out. When the highest address is reached, the address counter will roll over to the 000000h address, allowing the entire memory to be read with a single FAST READ instruction. The FAST READ instruction is terminated by driving CE# high (VIH).

If the FAST READ instruction is issued while an Erase, Program or Write cycle is in process (WIP=1) the instruction is ignored without affecting the current cycle.

Figure 8.2 Fast Read Sequence





FAST READ QPI OPERATION (FRD QPI, 0Bh)

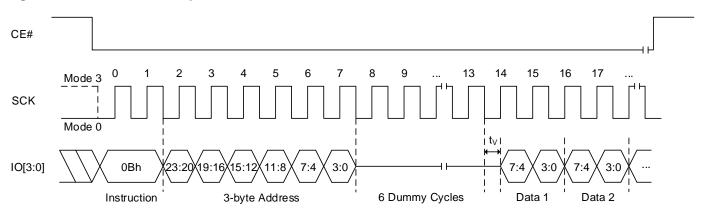
The FAST READ QPI (FRD QPI) instruction is used to read memory data at up to a 133MHz clock.

The FAST READ QPI instruction code (2 clocks) is followed by three address bytes (A23-A0—6clocks) and dummy cycles (configurable, default is 6 clocks), transmitted via the IO3, IO2, IO1 and IO0 lines, with each bit latched-in during the rising edge of SCK. Then the first data byte addressed is shifted out on the IO3, IO2, IO1 and IO0 lines, with each bit shifted out at a maximum frequency fct, during the falling edge of SCK.

The first byte addressed can be at any memory location. The address is automatically incremented by one after each byte of data is shifted out. When the highest address is reached, the address counter will roll over to the 000000h address, allowing the entire memory to be read with a single FAST READ QPI instruction. The FAST READ QPI instruction is terminated by driving CE# high (VIH).

If the FAST READ QPI instruction is issued while an Erase, Program or Write cycle is in process (WIP=1) the instruction is ignored without affecting the current cycle.

Figure 8.3 Fast Read QPI Sequence



Note: Number of dummy cycles depends on Read Parameter setting. Detailed information in Table 6.10 Read Dummy Cycles.



8.3 HOLD OPERATION

HOLD# is used in conjunction with CE# to select the device. When the device is selected and a serial sequence is underway, HOLD# can be used to pause the serial communication with the master device without resetting the serial sequence. To pause, HOLD# is brought low while the SCK signal is low. To resume serial communication, HOLD# is brought high while the SCK signal is low (SCK may still toggle during HOLD). Inputs to SI will be ignored while SO is in the high impedance state, during HOLD.

Note: HOLD is not supported in DTR mode or with QE=1 or for the specific parts that do not have HOLD# pin.

Timing graph can be referenced in AC Parameters Figure 9.4.

8.4 FAST READ DUAL I/O OPERATION (FRDIO, BBh)

The FRDIO allows the address bits to be input two bits at a time. This may allow for code to be executed directly from the SPI in some applications.

The FRDIO instruction code is followed by three address bytes (A23 – A0) and dummy cycles (configurable, default is 4 clocks), transmitted via the IO0 and IO1 lines, with each pair of bits latched-in during the rising edge of SCK. The address MSB is input on IO1, the next bit on IO0, and this shift pattern continues to alternate between the two lines. Depending on the usage of AX read operation mode, a mode byte may be located after address input.

The first data byte addressed is shifted out on the IO1 and IO0 lines, with each pair of bits shifted out at a maximum frequency fcT, during the falling edge of SCK. The MSB is output on IO1, while simultaneously the second bit is output on IO0. Figure 8.4 illustrates the timing sequence.

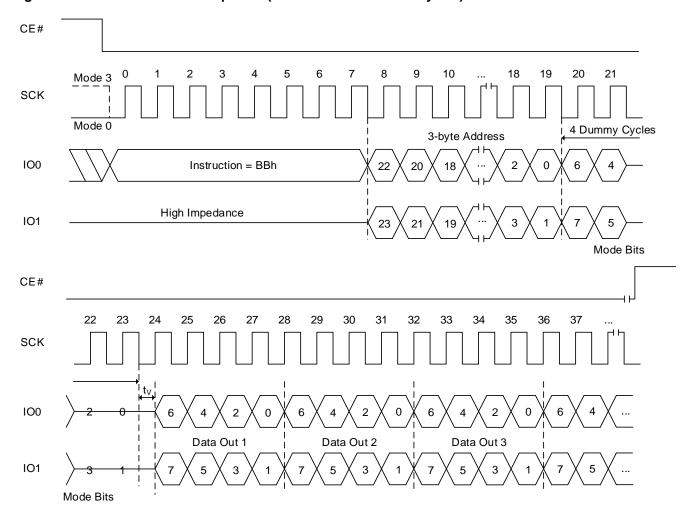
The first byte addressed can be at any memory location. The address is automatically incremented by one after each byte of data is shifted out. When the highest address is reached, the address counter will roll over to the 000000h address, allowing the entire memory to be read with a single FRDIO instruction. FRDIO instruction is terminated by driving CE# high (VIH).

The device supports the AX read operation by applying mode bits during dummy period. Mode bits consist of 8 bits, such as M7 to M0. Four cycles after address input are reserved for Mode bits in FRDIO execution. M7 to M4 are important for enabling this mode. M3 to M0 become don't care for future use. When M[7:4]=1010(Ah), it enables the AX read operation and subsequent FRDIO execution skips command code. It saves cycles as described in Figure 8.5. When the code is different from AXh (where X is don't care), the device exits the AX read operation. After finishing the read operation, device becomes ready to receive a new command. SPI or QPI mode configuration retains the prior setting. Mode bit must be applied during dummy cycles. Number of dummy cycle in Table 6.10 includes number of mode bit cycles. If dummy cycles is configured as 4 cycles, data output will starts right after mode bit applied.

If the FRDIO instruction is issued while an Erase, Program or Write cycle is in process (WIP=1) the instruction is ignored and will not affect the current cycle.



Figure 8.4 Fast Read Dual I/O Sequence (with command decode cycles)

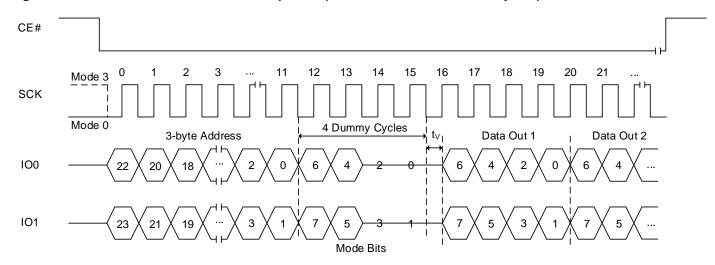


Notes:

- 1. If the mode bits=AXh (where X is don't care), it can execute the AX read mode (without command). When the mode bits are different from AXh, the device exits the AX read operation.
- 2. Number of dummy cycles depends on clock speed. Detailed information in Table 6.10 Read Dummy Cycles.
- 3. Since the number of dummy cycles and AX bit cycles are same in the above Figure, X should be Hi-Z to avoid I/O contention.



Figure 8.5 Fast Read Dual I/O AX Read Sequence (without command decode cycles)



Notes:

- 1. If the mode bits=AXh (where X is don't care), it will keep executing the AX read mode (without command). When the mode bits are different from AXh, the device exits the AX read operation.
- 2. Number of dummy cycles depends on clock speed. Detailed information in Table 6.10 Read Dummy Cycles.
- 3. Since the number of dummy cycles and AX bit cycles are same in the above Figure, X should be Hi-Z to avoid I/O contention.



8.5 FAST READ DUAL OUTPUT OPERATION (FRDO, 3Bh)

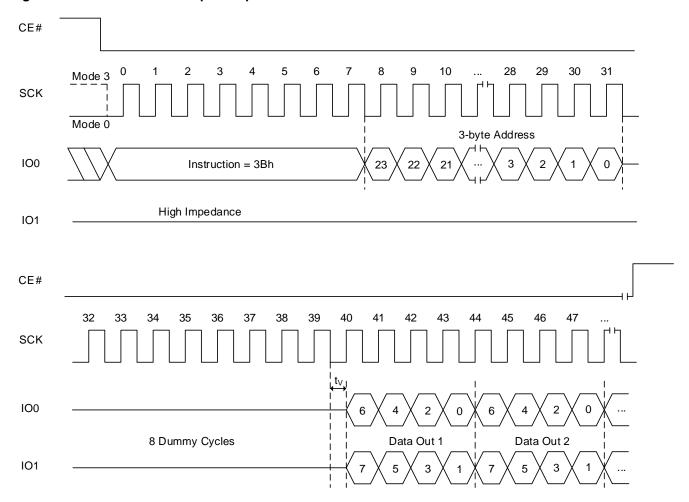
The FRDO instruction is used to read memory data on two output pins each at up to a 133MHz clock.

The FRDO instruction code is followed by three address bytes (A23 – A0) and a dummy byte (8 clocks), transmitted via the IO0 line, with each bit latched-in during the rising edge of SCK. Then the first data byte addressed is shifted out on the IO1 and IO0 lines, with each pair of bits shifted out at a maximum frequency fC, during the falling edge of SCK. The first bit (MSB) is output on IO1, while simultaneously the second bit is output on IO0.

The first byte addressed can be at any memory location. The address is automatically incremented by one after each byte of data is shifted out. When the highest address is reached, the address counter will roll over to the 000000h address, allowing the entire memory to be read with a single FRDO instruction. The FRDO instruction is terminated by driving CE# high (VIH).

If the FRDO instruction is issued while an Erase, Program or Write cycle is in process (BUSY=1) the instruction is ignored and will not have any effects on the current cycle.

Figure 8.6 Fast Read Dual Output Sequence





8.6 FAST READ QUAD OUTPUT OPERATION (FRQO, 6Bh)

The FRQO instruction is used to read memory data on four output pins each at up to a 133 MHz clock.

A Quad Enable (QE) bit of Status Register must be set to "1" before sending the Fast Read Quad Output instruction.

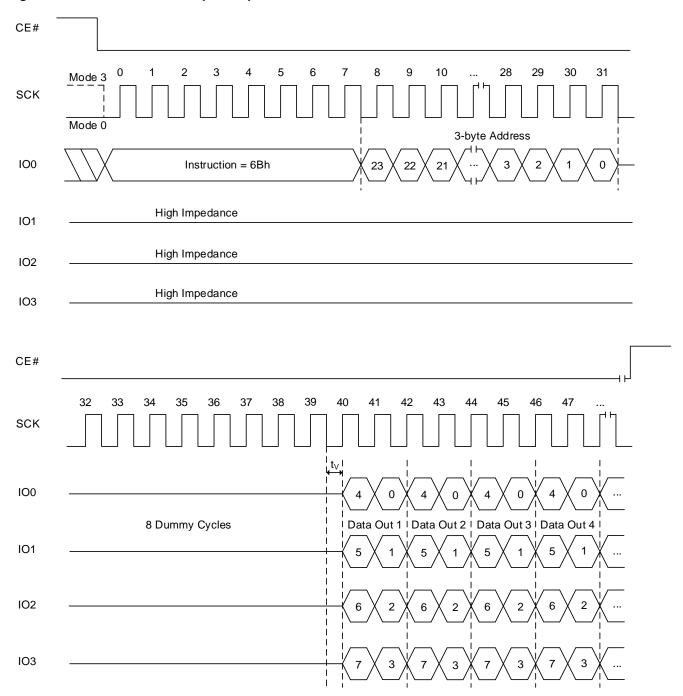
The FRQO instruction code is followed by three address bytes (A23 – A0) and a dummy byte (8 clocks), transmitted via the IO0 line, with each bit latched-in during the rising edge of SCK. Then the first data byte addressed is shifted out on the IO3, IO2, IO1 and IO0 lines, with each group of four bits shifted out at a maximum frequency fCT, during the falling edge of SCK. The first bit (MSB) is output on IO3, while simultaneously the second bit is output on IO2, the third bit is output on IO1, etc.

The first byte addressed can be at any memory location. The address is automatically incremented after each byte of data is shifted out. When the highest address is reached, the address counter will roll over to the 000000h address, allowing the entire memory to be read with a single FRQO instruction. FRQO instruction is terminated by driving CE# high (VIH).

If a FRQO instruction is issued while an Erase, Program or Write cycle is in process (BUSY=1) the instruction is ignored and will not have any effects on the current cycle.



Figure 8.7 Fast Read Quad Output Sequence





8.7 FAST READ QUAD I/O OPERATION (FRQIO, EBh)

The FRQIO instruction allows the address bits to be input four bits at a time. This may allow for code to be executed directly from the SPI in some applications.

A Quad Enable (QE) bit of Status Register must be set to "1" before sending the Fast Read Quad I/O instruction.

The FRQIO instruction code is followed by three address bytes (A23 – A0) and dummy cycles (configurable, default is 6 clocks), transmitted via the IO3, IO2, IO0 and IO1 lines, with each group of four bits latched-in during the rising edge of SCK. The address of MSB inputs on IO3, the next bit on IO2, the next bit on IO1, the next bit on IO0, and continue to shift in alternating on the four. Depending on the usage of AX read operation mode, a mode byte may be located after address input.

The first data byte addressed is shifted out on the IO3, IO2, IO1 and IO0 lines, with each group of four bits shifted out at a maximum frequency f_{CT} , during the falling edge of SCK. The first bit (MSB) is output on IO3, while simultaneously the second bit is output on IO2, the third bit is output on IO1, etc. Figure 8.8 illustrates the timing sequence.

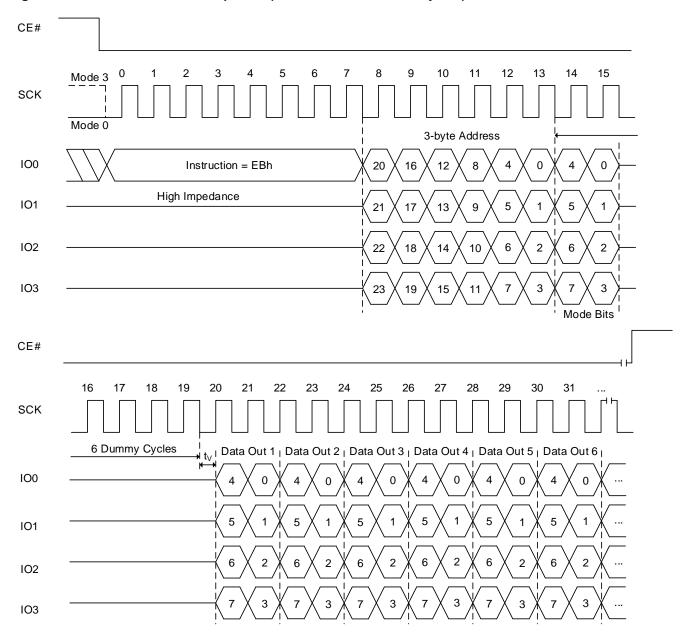
The first byte addressed can be at any memory location. The address is automatically incremented after each byte of data is shifted out. When the highest address is reached, the address counter will roll over to the 000000h address, allowing the entire memory to be read with a single FRQIO instruction. FRQIO instruction is terminated by driving CE# high (V_{IH}) .

The device supports the AX read operation by applying mode bits during dummy period. Mode bits consists of 8 bits, such as M7 to M0. Two cycles after address input are reserved for Mode bits in FRQIO execution. M7 to M4 are important for enabling this mode. M3 to M0 become don't care for future use. When M[7:4]=1010(Ah), it enables the AX read operation and subsequent FRQIO execution skips command code. It saves cycles as described in Figure 8.9. When the code is different from AXh (where X is don't care), the device exits the AX read operation. After finishing the read operation, device becomes ready to receive a new command. SPI or QPI mode configuration retains the prior setting. Mode bit must be applied during dummy cycles. Number of dummy cycle in Table 6.10 includes number of mode bit cycles. If dummy cycles is configured as 6 cycles, data output will starts right after mode bits and 4 additional dummy cycles are applied

If the FRQIO instruction is issued while an Erase, Program or Write cycle is in process (WIP=1) the instruction is ignored and will not have any effects on the current cycle.



Figure 8.8 Fast Read Quad I/O Sequence (with command decode cycles)

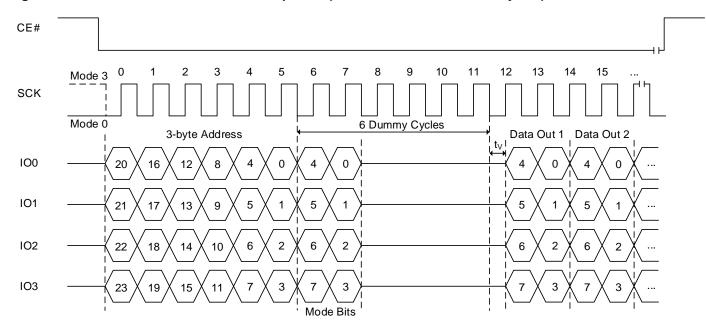


Notes:

- 1. If the mode bits=AXh (where X is don't care), it can execute the AX read mode (without command). When the mode bits are different from AXh, the device exits the AX read operation.
- 2. Number of dummy cycles depends on clock speed. Detailed information in Table 6.10 Read Dummy Cycles.



Figure 8.9 Fast Read Quad I/O AX Read Sequence (without command decode cycles)



Notes:

- 1. If the mode bits=AXh (where X is don't care), it will keep executing the AX read mode (without command). When the mode bits are different from AXh, the device exits the AX read operation.
- 2. Number of dummy cycles depends on clock speed. Detailed information in Table 6.10 Read Dummy Cycles.



FAST READ QUAD I/O OPERATION IN QPI MODE (FRQIO, EBh)

The FRQIO instruction in QPI mode is used to read memory data.

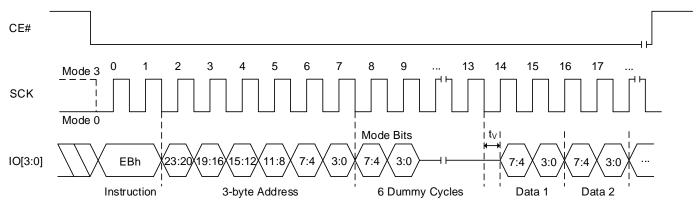
It is not required to set QE bit to "1".before Fast Read Quad I/O instruction in QPI mode.

The FRQIO instruction in QPI mode utilizes all four IO lines to input the instruction code so that only two clocks are required, while the FRQIO instruction in QPI mode requires that the byte-long instruction code is shifted into the device only via IO0 line in eight clocks. As a result, 6 command cycles will be reduced by the FRQIO instruction in QPI mode. In addition, subsequent address and data out are shifted in/out via all four IO lines like the FRQIO instruction in SPI mode. In fact, except for the command cycle, the FRQIO operation in QPI mode is exactly same as the FRQIO operation in SPI mode.

The device supports the AX read operation by applying mode bits during dummy period. Mode bits consist of 8 bits, such as M7 to M0. Two cycles after address input are reserved for Mode bits in FRQIO execution. M7 to M4 are important for enabling this mode. M3 to M0 become don't care for future use. When M[7:4]=1010(Ah), it enables the AX read operation and subsequent FRQIO execution skips command code. It saves cycles as described in Figure 8.9. When the code is different from AXh (where X is don't care), the device exits the AX read operation. After finishing the read operation, device becomes ready to receive a new command. SPI or QPI mode configuration retains the prior setting. Mode bit must be applied during dummy cycles. Number of dummy cycles in Table 6.10 includes number of mode bit cycles. If dummy cycles are configured as 6 cycles, data output will start right after mode bits and 4 additional dummy cycles are applied.

If the FRQIO instruction in QPI mode is issued while an Erase, Program or Write cycle is in process (WIP=1) the instruction is ignored and will not have any effects on the current cycle.

Figure 8.10 Fast Read Quad I/O Sequence IN QPI MOde



Note: Number of dummy cycles depends on Read Parameter setting. Detailed information in Table 6.10 Read Dummy Cycles.



8.8 PAGE PROGRAM OPERATION (PP, 02h)

The Page Program (PP) instruction allows up to 256 bytes data to be programmed into memory in a single operation. The destination of the memory to be programmed must be outside the protected memory area set by the Block Protection (BP3, BP2, BP1, BP0) bits. A PP instruction which attempts to program into a page that is write-protected will be ignored. Before the execution of PP instruction, the Write Enable Latch (WEL) must be enabled through a Write Enable (WREN) instruction.

The PP instruction code, three address bytes and program data (1 to 256 bytes) are input via the SI line. Program operation will start immediately after the CE# is brought high, otherwise the PP instruction will not be executed. The internal control logic automatically handles the programming voltages and timing. The progress or completion of the program operation can be determined by reading the WIP bit in Status Register via a RDSR instruction. If the WIP bit is "1", the program operation is still in progress. If WIP bit is "0", the program operation has completed.

If more than 256 bytes data are sent to a device, the address counter rolls over within the same page, the previously latched data are discarded, and the last 256 bytes are kept to be programmed into the page. The starting byte can be anywhere within the page. When the end of the page is reached, the address will wrap around to the beginning of the same page. If the data to be programmed are less than a full page, the data of all other bytes on the same page will remain unchanged.

Note: A program operation can alter "1"s into "0"s, but an erase operation is required to change "0"s back to "1"s. A byte cannot be reprogrammed without first erasing the whole sector or block.



Figure 8.11 Page Program Sequence

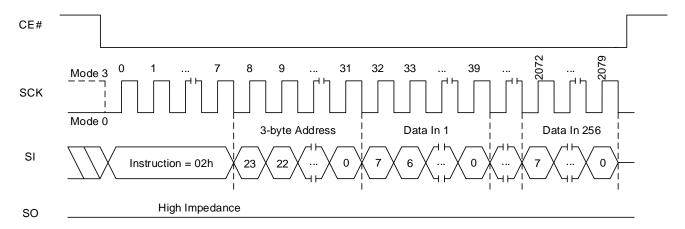
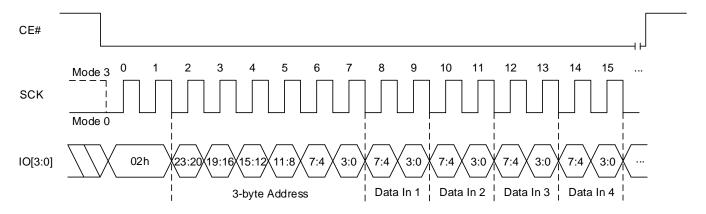


Figure 8.12 Page Program QPI Sequence





8.9 QUAD INPUT PAGE PROGRAM OPERATION (PPQ, 32h/38h)

The Quad Input Page Program instruction allows up to 256 bytes data to be programmed into memory in a single operation with four pins (IO0, IO1, IO2 and IO3). The destination of the memory to be programmed must be outside the protected memory area set by the Block Protection (BP3, BP2, BP1, BP0) bits. A Quad Input Page Program instruction which attempts to program into a page that is write-protected will be ignored.

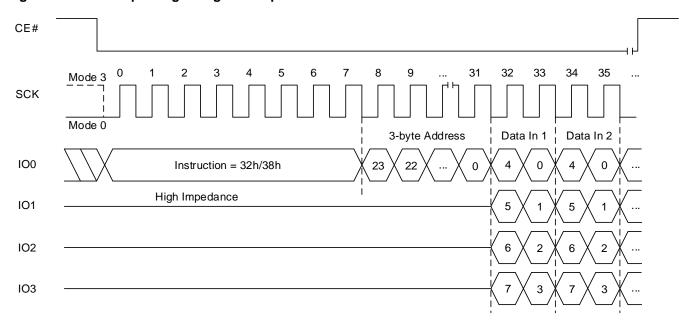
Before the execution of Quad Input Page Program instruction, the QE bit in the Status Register must be set to "1" and the Write Enable Latch (WEL) must be enabled through a Write Enable (WREN) instruction.

Program operation will start immediately after the CE# is brought high, otherwise the Quad Input Page Program instruction will not be executed. The internal control logic automatically handles the programming voltages and timing. The progress or completion of the program operation can be determined by reading the WIP bit in Status Register via a RDSR instruction. If the WIP bit is "1", the program operation is still in progress. If WIP bit is "0", the program operation has completed.

If more than 256 bytes data are sent to a device, the address counter rolls over within the same page, the previously latched data are discarded, and the last 256 bytes data are kept to be programmed into the page. The starting byte can be anywhere within the page. When the end of the page is reached, the address will wrap around to the beginning of the same page. If the data to be programmed are less than a full page, the data of all other bytes on the same page will remain unchanged.

Note: A program operation can alter "1"s into "0"s. The same byte location or page may be programmed more than once, to incrementally change "1"s to "0"s. An erase operation is required to change "0"s to "1"s.

Figure 8.13 Quad Input Page Program Sequence





8.10 ERASE OPERATION

The Erase command sets all bits in the addressed sector or block to "1"s.

The memory array of the device is organized into uniform 4 Kbyte sectors or 32/64 Kbyte uniform blocks (a block consists of eight/sixteen adjacent sectors respectively).

Before a byte is reprogrammed, the sector or block that contains the byte must be erased (erasing sets bits to "1"). In order to erase the device, there are three erase instructions available: Sector Erase (SER), Block Erase (BER) and Chip Erase (CER). A sector erase operation allows any individual sector to be erased without affecting the data in other sectors. A block erase operation erases any individual block. A chip erase operation erases the whole memory array of a device. A sector erase, block erase, or chip erase operation can be executed prior to any programming operation.



8.11 SECTOR ERASE OPERATION (SER, D7h/20h)

A Sector Erase (SER) instruction erases a 4 Kbyte sector before the execution of a SER instruction, the Write Enable Latch (WEL) must be set via a Write Enable (WREN) instruction. The WEL bit is automatically reset after the completion of Sector Erase operation.

A SER instruction is entered, after CE# is pulled low to select the device and stays low during the entire instruction sequence. The SER instruction code, and three address bytes are input via SI. Erase operation will start immediately after CE# is pulled high. The internal control logic automatically handles the erase voltage and timing.

The progress or completion of the erase operation can be determined by reading the WIP bit in the Status Register using a RDSR instruction.

If the WIP bit is "1", the erase operation is still in progress. If the WIP bit is "0", the erase operation has been completed.

Figure 8.14 Sector Erase Sequence

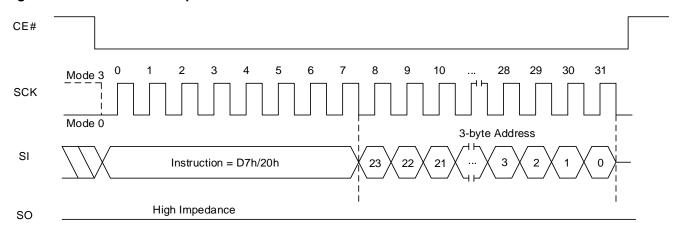
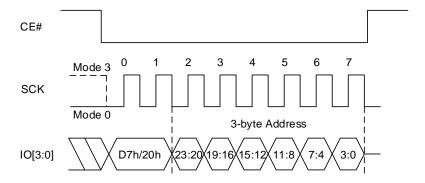


Figure 8.15 Sector Erase QPI Sequence





8.12 BLOCK ERASE OPERATION (BER32K:52h, BER64K:D8h)

A Block Erase (BER) instruction erases a 32/64 Kbyte block. Before the execution of a BER instruction, the Write Enable Latch (WEL) must be set via a Write Enable (WREN) instruction. The WEL is reset automatically after the completion of a block erase operation.

The BER instruction code and three address bytes are input via SI. Erase operation will start immediately after the CE# is pulled high, otherwise the BER instruction will not be executed. The internal control logic automatically handles the erase voltage and timing.

Figure 8.16 Block Erase (64KB) Sequence

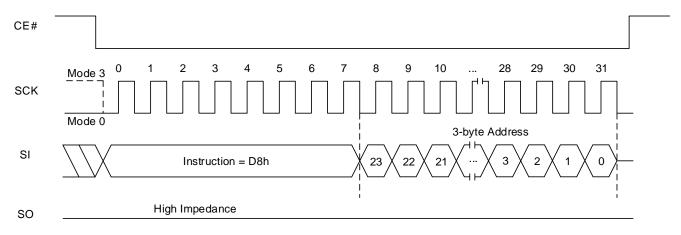


Figure 8.17 Block Erase (64KB) QPI Sequence

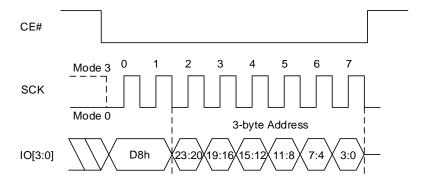




Figure 8.18 Block Erase (32KB) Sequence

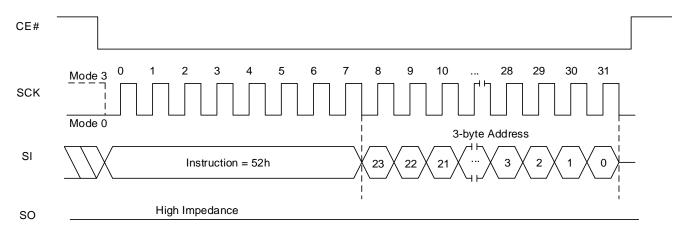
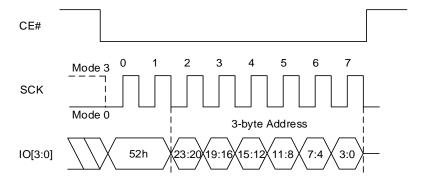


Figure 8.19 Block Erase (32KB) QPI Sequence





8.13 CHIP ERASE OPERATION (CER, C7h/60h)

A Chip Erase (CER) instruction erases the entire memory array. Before the execution of CER instruction, the Write Enable Latch (WEL) must be set via a Write Enable (WREN) instruction. The WEL is automatically reset after completion of a chip erase operation.

The CER instruction code is input via the SI. Erase operation will start immediately after CE# is pulled high, otherwise the CER instruction will not be executed. The internal control logic automatically handles the erase voltage and timing.

Figure 8.20 Chip Erase Sequence

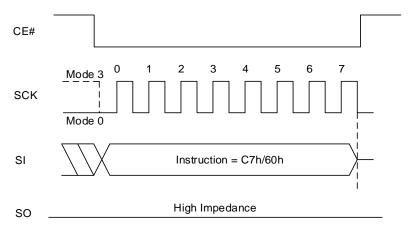
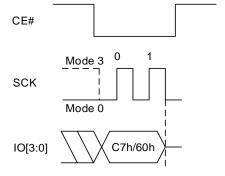


Figure 8.21 Chip Erase QPI Sequence





8.14 WRITE ENABLE OPERATION (WREN, 06h)

The Write Enable (WREN) instruction is used to set the Write Enable Latch (WEL) bit. The WEL bit is reset to the write-protected state after power-up. The WEL bit must be write enabled before any write operation, including Sector Erase, Block Erase, Chip Erase, Page Program, Program Information Row, Write Status Register, and Write Function Register operations. The WEL bit will be reset to the write-protected state automatically upon completion of a write operation. The WREN instruction is required before any above operation is executed.

Figure 8.22 Write Enable Sequence

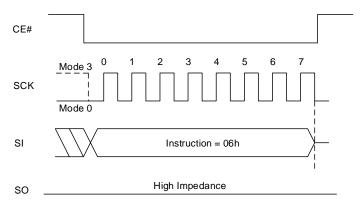
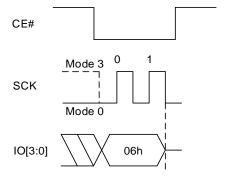


Figure 8.23 Write Enable QPI Sequence





8.15 WRITE DISABLE OPERATION (WRDI, 04h)

The Write Disable (WRDI) instruction resets the WEL bit and disables all write instructions. The WRDI instruction is not required after the execution of a write instruction, since the WEL bit is automatically reset.

Figure 8.24 Write Disable Sequence

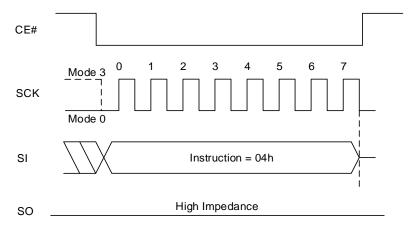
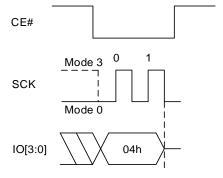


Figure 8.25 Write Disable QPI Sequence





8.16 READ STATUS REGISTER OPERATION (RDSR, 05h)

The Read Status Register (RDSR) instruction provides access to the Status Register. During the execution of a program, erase or write Status Register operation, RDSR instruction can be used to check the progress or completion of an operation by reading the WIP bit of Status Register.

Figure 8.26 Read Status Register Sequence

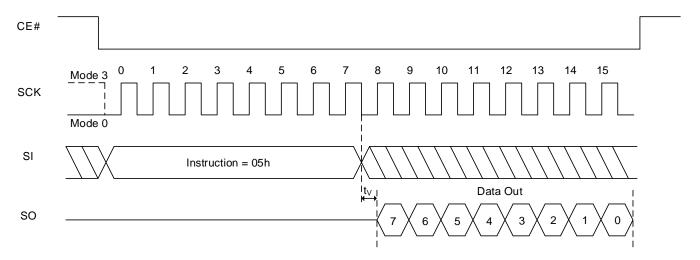
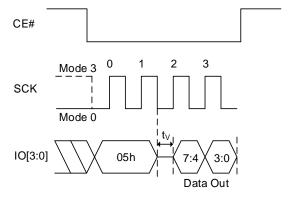


Figure 8.27 Read Status Register QPI Sequence





8.17 WRITE STATUS REGISTER OPERATION (WRSR, 01h)

The Write Status Register (WRSR) instruction allows the user to enable or disable the block protection and Status Register write protection features by writing "0"s or "1"s into the non-volatile BP3, BP2, BP1, BP0, and SRWD bits. Also WRSR instruction allows the user to disable or enable quad operation by writing "0" or "1" into the non-volatile QE bit.

Figure 8.28 Write Status Register Sequence

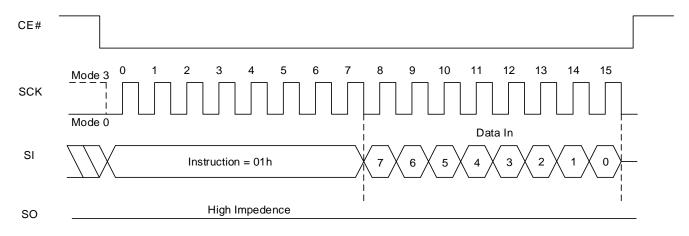
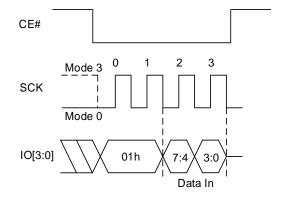


Figure 8.29 Write Status Register QPI Sequence





8.18 READ FUNCTION REGISTER OPERATION (RDFR, 48h)

The Read Function Register (RDFR) instruction provides access to the Function Register. Refer to Table 6.6 Function Register Bit Definition for more detail.

Figure 8.30 Read Function Register Sequence

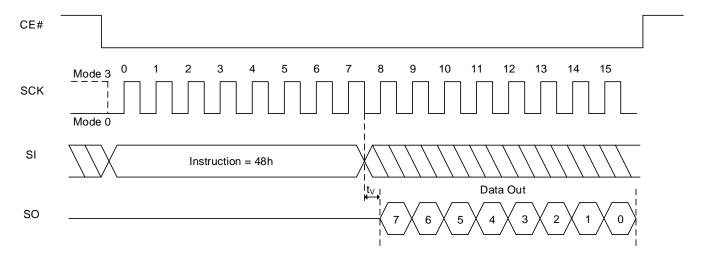
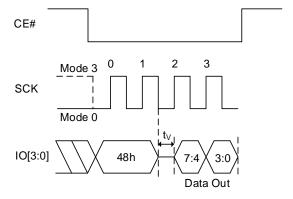


Figure 8.31 Read Function Register QPI Sequence





8.19 WRITE FUNCTION REGISTER OPERATION (WRFR, 42h)

The Write Function Register (WRFR) instruction allows the user to change from top block area (default) to bottom block area by setting TBS bit to "1".

Also Information Row Lock bits (IRL3~IRL0) can be set to "1" individually by WRFR instruction in order to lock Information Row. Since TBS bit and IRL bits are OTP, once it is set to "1", it cannot be set back to "0" again.

Figure 8.32 Write Function Register Sequence

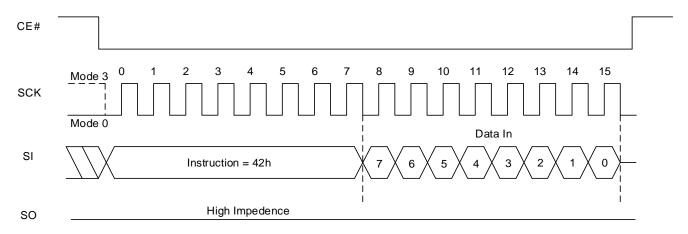
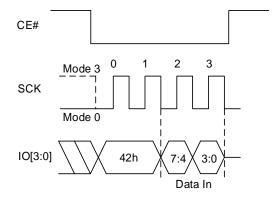


Figure 8.33 Write Function Register QPI Sequence





8.20 ENTER QUAD PERIPHERAL INTERFACE (QPI) MODE OPERATION (QPIEN,35h; QPIDI,F5h)

The Enter Quad Peripheral Interface (QPIEN) instruction, 35h, enables the Flash device for QPI bus operation. Upon completion of the instruction, all instructions thereafter will be 4-bit multiplexed input/output until a power cycle or an Exit Quad Peripheral Interface instruction is sent to device.

The Exit Quad Peripheral Interface (QPIDI) instruction, F5h, resets the device to 1-bit SPI protocol operation. To execute an Exit Quad Peripheral Interface operation, the host drives CE# low, sends the QPIDI instruction, then drives CE# high. The device just accepts QPI (2 clocks) command cycles.

Figure 8.34 Enter Quad Peripheral Interface (QPI) Mode Sequence

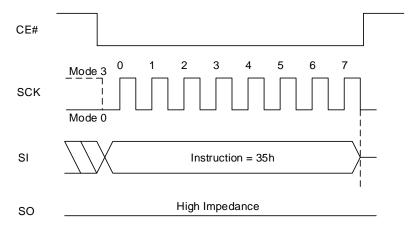
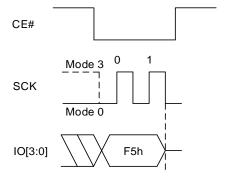


Figure 8.35 Exit Quad Peripheral Interface (QPI) Mode Sequence





8.21 PROGRAM/ERASE SUSPEND & RESUME

The device allows the interruption of Sector-Erase, Block-Erase or Page-Program operations to conduct other operations. 75h/B0h command for suspend and 7Ah/30h for resume will be used (SPI/QPI all acceptable). Function Register bit2 (PSUS) and bit3 (ESUS) are used to check whether or not the device is in suspend mode.

Suspend to read ready timing: 100µs Resume to another suspend timing: 400µs

PROGRAM/ERASE SUSPEND DURING SECTOR-ERASE OR BLOCK-ERASE (PERSUS 75h/B0h)

The Program/Erase Suspend allows the interruption of Sector Erase and Block Erase operations. After the Program/Erase Suspend, WEL bit will be disabled, therefore only read related, resume and reset commands can be accepted. Refer to Table 8.3 for more detail.

To execute a Program/Erase Suspend operation, the host drives CE# low, sends the Program/Erase Suspend command cycle (75h/B0h), then drives CE# high. The Function Register indicates that the erase has been suspended by changing the ESUS bit from "0" to "1", but the device will not accept another command until it is ready. To determine when the device will accept a new command, poll the WIP bit in the Status Register or wait the specified time t_{SUS}. When ESUS bit is issued, the Write Enable Latch (WEL) bit will be reset.

PROGRAM/ERASE SUSPEND DURING PAGE PROGRAMMING (PERSUS 75h/B0h)

The Program/Erase Suspend allows the interruption of all array program operations. After the Program/Erase Suspend command, WEL bit will be disabled, therefore only read related, resume and reset command can be accepted. Refer to Table 8.3 for more detail.

To execute the Program/Erase Suspend operation, the host drives CE# low, sends the Program/Erase Suspend command cycle (75h/B0h), then drives CE# high. The Function Register indicates that the programming has been suspended by changing the PSUS bit from "0" to "1", but the device will not accept another command until it is ready. To determine when the device will accept a new command, poll the WIP bit in the Status Register or wait the specified time t_{SUS}.

PROGRAM/ERASE RESUME (PERRSM 7Ah/30h)

The Program/Erase Resume restarts a Program/Erase command that was suspended, and changes the suspend status bit in the Function Register (ESUS or PSUS bits) back to "0". To execute a Program/Erase Resume operation, the host drives CE# low, sends the Program/Erase Resume command cycle (7Ah/30h), then drives CE# high. A cycle is two nibbles long, most significant nibble first. To determine if the internal, self-timed Write operation completed, poll the WIP bit in the Status Register, or wait the specified time t_{SE} , t_{BE} or t_{PP} for Sector Erase, Block Erase, or Page Programming, respectively. The total write time before suspend and after resume will not exceed the uninterrupted write times t_{SE} , t_{BE} or t_{PP} .



Table 8.3 Instructions accepted during Suspend

Operation	Instruction Allowed			
Suspended	Name Hex Code		Operation	
Program or Erase	NORD	03h	Read Data Bytes from Memory at Normal Read Mode	
Program or Erase	FRD	0Bh	Read Data Bytes from Memory at Fast Read Mode	
Program or Erase	FRDIO	BBh	Fast Read Dual I/O	
Program or Erase	FRDO	3Bh	Fast Read Dual Output	
Program or Erase	FRQIO	EBh	Fast Read Quad I/O	
Program or Erase	FRDTR	0Dh	Fast Read DTR Mode	
Program or Erase	FRDDTR	BDh	Fast Read Dual I/O DTR	
Program or Erase	FRQDTR	EDh	Fast Read Quad I/O DTR	
Program or Erase	RDSR	05h	Read Status Register	
Program or Erase	RDFR	48h	Read Function Register	
Program or Erase	PERRSM	7Ah/30h	Resume program/erase	
Program or Erase	RDID	ABh	Read Manufacturer and Product ID	
Program or Erase	SRV	C0	Set Read Parameters (Volatile)	
Program or Erase	RDJDID	9Fh	Read Manufacturer and Product ID by JEDEC ID Command	
Program or Erase	RDMDID	90h	Read Manufacturer and Device ID	
Program or Erase	RDJDIDQ	AFh	Read JEDEC ID QPI mode	
Program or Erase	RDUID	4Bh	Read Unique ID Number	
Program or Erase	RDSFDP	5Ah	SFDP Read	
Program or Erase	NOP	00h	No Operation	
Program or Erase	RSTEN	66h	Software reset enable	
Program or Erase	RST	99h	Reset (Only along with 66h)	
Program or Erase	IRRD	68h	Read Information Row	



8.22 ENTER DEEP POWER DOWN (DP, B9h)

The Enter Deep Power-down (DP) instruction is for setting the device on the minimizing the power consumption (enter into Power-down mode). During this mode, standby current is reduced from I_{sb1} to I_{sb2} . While in the Power-down mode, the device is not active and all Write/Program/Erase instructions are ignored. The instruction is initiated by driving the CE# pin low and shifting the instruction code into the device. The CE# pin must be driven high after the instruction has been latched, or Power-down mode will not engage. Once CE# pin driven high, the Power-down mode will be entered within the time duration of t_{DP} . While in the Power-down mode only the Release from Power-down/RDID instruction, which restores the device to normal operation, will be recognized. All other instructions are ignored, including the Read Status Register instruction which is always available during normal operation. Ignoring all but one instruction makes the Power Down state a useful condition for securing maximum write protection. It is available in both SPI and QPI mode.

Figure 8.36 Enter Deep Power Down Mode Sequence

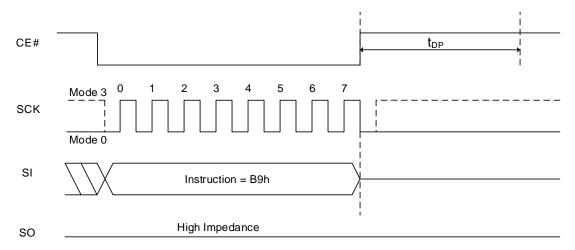
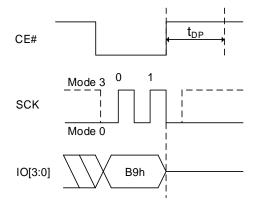


Figure 8.37 Enter Deep Power Down Mode QPI Sequence





8.23 RELEASE DEEP POWER DOWN (RDPD, ABh)

The Release Deep Power-down/Read Device ID instruction is a multi-purpose command. To release the device from the Power-down mode, the instruction is issued by driving the CE# pin low, shifting the instruction code "ABh" and driving CE# high.

Releasing the device from Power-down mode will take the time duration of tRES1 before normal operation is restored and other instructions are accepted. The CE# pin must remain high during the tRES1 time duration. If the Release Deep Power-down/RDID instruction is issued while an Erase, Program or Write cycle is in progress (WIP=1) the instruction is ignored and will not have any effects on the current cycle.

Figure 8.38 Release Power Down Sequence

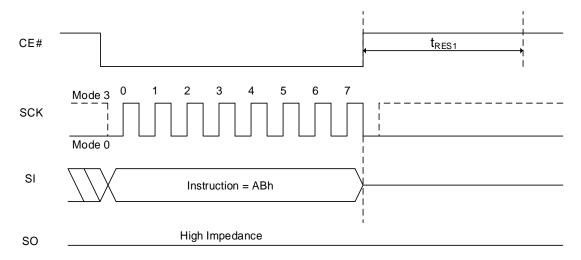
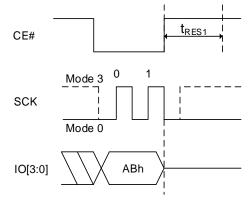


Figure 8.39 Release Power Down QPI Sequence





8.24 SET READ PARAMETERS OPERATION (SRP, C0h)

Set Read Operational Driver Strength

This device supports configurable Operational Driver Strengths in both SPI and QPI modes by setting three bits within the READ Register (ODS0, ODS1, ODS2). To set the ODS bits the SRP operation (C0h) instruction is required. The device's driver strength can be reduced as low as 12.50% of full drive strength. Details regarding the driver strength can be found in table 6.11.

Note: The default driver strength is set to 50%

Figure 8.40 Set Read Parameters Sequence

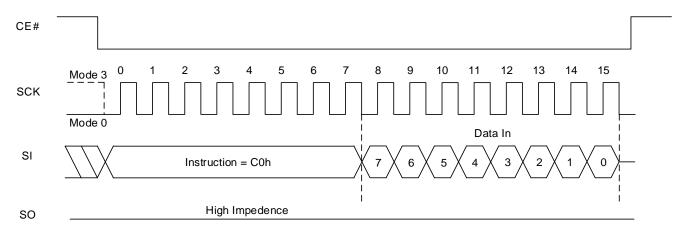
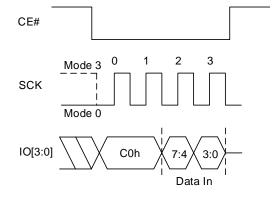


Figure 8.41 Set Read Parameters QPI Sequence





Read with "8/16/32/64-Byte Wrap Around"

The device is capable of burst read with wrap around in both SPI and QPI mode. The size of burst length is configurable by using P0, P1, and P2 bits in READ Register. P2 bit (Wrap enable) enables the burst mode feature. P0 and P1 define the size of burst. Burst lengths of 8, 16, 32, and 64 bytes are supported. By default, address increases by one up through the entire array. By setting the burst length, the data being accessed can be limited to the length of burst boundary within a 256 byte page. The first output will be the data at the initial address which is specified in the instruction. Following data will come out from the next address within the burst boundary. Once the address reaches the end of boundary, it will automatically move to the first address of the boundary. CE# high will terminate the command.

For example, if burst length of 8 and initial address being applied is 0h, following byte output will be from address 00h and continue to 01h,..,07h, 00h, 01h... until CE# terminates the operation. If burst length of 8 and initial address being applied is FEh(254d), following byte output will be from address FEh and continue to FFh, F8h, F9h, FAh, FBh, FCh, FDh, and repeat from FEh until CE# terminates the operation.

The command, "SET READ PARAMETERS OPERATION (C0h)", is used to configure the burst length. If the following data input is one of "00h","01h","02h", and "03h", the device will be in default operation mode. It will be continuous burst read of the whole array. If the following data input is one of "04h","05h","06h", and "07h", the device will set the burst length as 8,16,32 and 64 respectively.

To exit the burst mode, another "C0h" command is necessary to set P2 to 0. Otherwise, the burst mode will be retained until either power down or reset operation. To change burst length, another "C0h" command should be executed to set P0 and P1 (Detailed information in Table 6.8 Burst Length Data). All read commands operate in burst mode once the READ Register is set to enable burst mode.

Refer to Figures 8.40 and 8.41 for instruction sequence.



8.25 READ PRODUCT IDENTIFICATION (RDID, ABh)

The Release from Power-down/Read Device ID instruction is a multi-purpose instruction. It can support both SPI and QPI modes. The Read Product Identification (RDID) instruction is for reading out the old style of 8-bit Electronic Signature, whose values are shown as table of Product Identification.

The RDID instruction code is followed by three dummy bytes, each bit being latched-in on SI during the rising SCK edge. Then the Device ID is shifted out on SO with the MSB first, each bit been shifted out during the falling edge of SCK. The RDID instruction is ended by driving CE# high. The Device ID (ID7-ID0) outputs repeatedly if additional clock cycles are continuously sent to SCK while CE# is at low.

Table 8.4 Product Identification

Manufacturer ID		(MF7-MF0)		
XMC Serial Flash		20h		
Instruction	ABh	90h	9Fh	
Device Density	Device ID (ID	07-ID0)	Memory Type + Capacity (ID15-ID0)	
128Mb 17		7h	6018h	

Figure 8.42 Read Product Identification Sequence

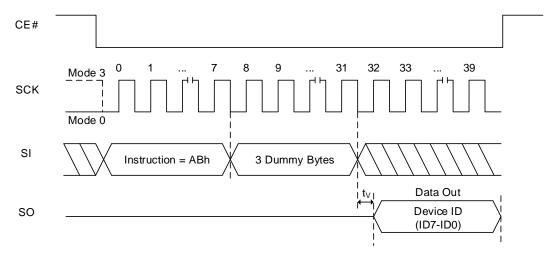
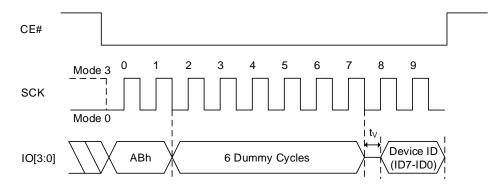




Figure 8.43 Read Product Identification QPI Sequence





8.26 READ PRODUCT IDENTIFICATION BY JEDEC ID OPERATION (RDJDID, 9Fh; RDJDIDQ, AFh)

The JEDEC ID READ instruction allows the user to read the Manufacturer and product ID of devices. Refer to Table 8.4 Product Identification for Manufacturer ID and Device ID. After the JEDEC ID READ command (9Fh in SPI mode and QPI mode, AFh in QPI mode) is input, the Manufacturer ID is shifted out MSB first followed by the 2-byte electronic ID (ID15-ID0) that indicates Memory Type and Capacity, one bit at a time. Each bit is shifted out during the falling edge of SCK. If CE# stays low after the last bit of the 2-byte electronic ID, the Manufacturer ID and 2-byte electronic ID will loop until CE# is pulled high.

Figure 8.44 Read Product Identification by JEDEC ID Read Sequence in SPI mode

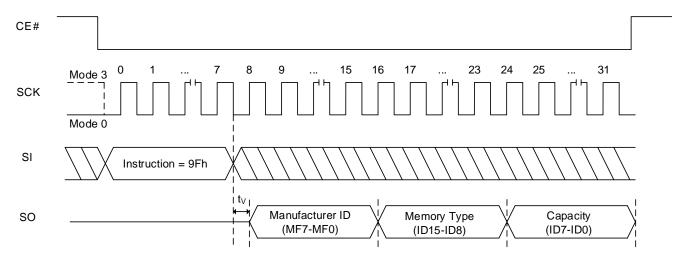
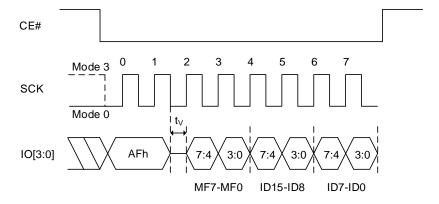


Figure 8.45 RDJDID and RDJDIDQ (Read JEDEC ID) Sequence in QPI mode

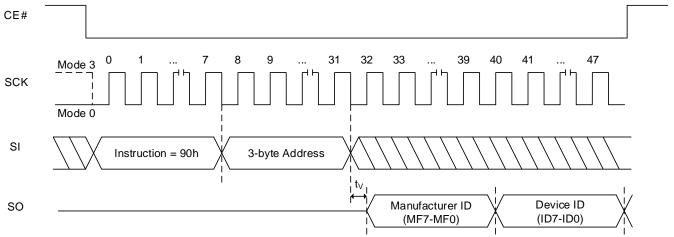




8.27 READ DEVICE MANUFACTURER AND DEVICE ID OPERATION (RDMDID, 90h)

The Read Device Manufacturer and Device ID (RDMDID) instruction allows the user to read the Manufacturer and product ID of devices. Refer to Table 8.4 Product Identification for Manufacturer ID and Device ID. The RDMDID instruction code is followed by two dummy bytes and one byte address (A7 \sim A0), each bit being latched-in on SI during the rising edge of SCK. If one byte address is initially set as A0 = 0, then the Manufacturer ID is shifted out on SO with the MSB first followed by the Device ID (ID7- ID0). Each bit is shifted out during the falling edge of SCK. If one byte address is initially set as A0 = 1, then Device ID will be read first followed by the Manufacturer ID. The Manufacturer and Device ID can be read continuously alternating between the two until CE# is driven high.

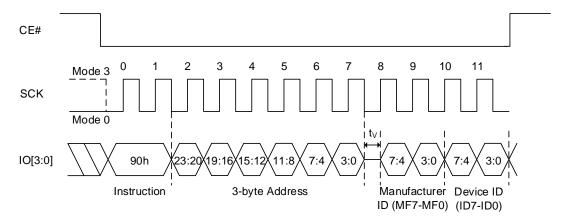




Notes:

- ADDRESS A0 = 0, will output the 1-byte Manufacturer ID (MF7-MF0) → 1-byte Device ID (ID7-ID0)
 ADDRESS A0 = 1, will output the 1-byte Device ID (ID7-ID0) → 1-byte Manufacturer ID (MF7-MF0)
- 2. The Manufacturer and Device ID can be read continuously and will alternate from one to the other until CE# pin is pulled high.

Figure 8.47 Read Product Identification by RDMDID QPI Read Sequence



Notes:

- ADDRESS A0 = 0, will output the 1-byte Manufacturer ID (MF7-MF0) → 1-byte Device ID (ID7-ID0)
 ADDRESS A0 = 1, will output the 1-byte Device ID (ID7-ID0) → 1-byte Manufacturer ID (MF7-MF0)
- 2. The Manufacturer and Device ID can be read continuously and will alternate from one to the other until CE# pin is pulled high.



8.28 READ UNIQUE ID NUMBER (RDUID, 4Bh)

The Read Unique ID Number (RDUID) instruction accesses a factory-set read-only 16-byte number that is unique to the device. The ID number can be used in conjunction with user software methods to help prevent copying or cloning of a system. The RDUID instruction is instated by driving the CE# pin low and shifting the instruction code (4Bh) followed by 3 address bytes and a dummy byte. After which, the 16-byte ID is shifted out on the falling edge of SCK as shown below.

As a result, the sequence of RDUID instruction is same as FAST READ except for the instruction code. RDUID QPI sequence is also same as FAST READ QPI except for the instruction code. Refer to the FAST READ QPI operation.

Note: 16 bytes of data will repeat as long as CE# is low and SCK is toggling.

Figure 8.48 RDUID Sequence

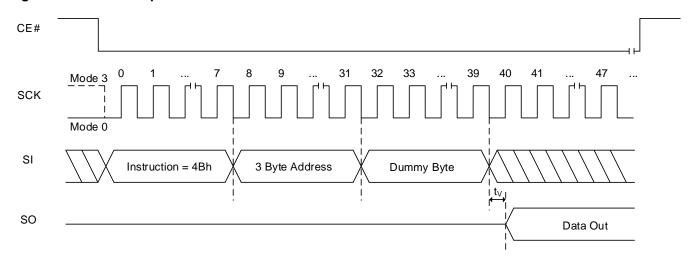


Table 8.5 Unique ID Addressing

A[23:16]	A[15:9]	A[8:4]	A[3:0]
XXh	XXh	00h	0h Byte address
XXh	XXh	00h	1h Byte address
XXh	XXh	00h	2h Byte address
XXh	XXh	00h	:
XXh	XXh	00h	Fh Byte address

Note: XX means "don't care".

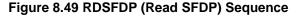


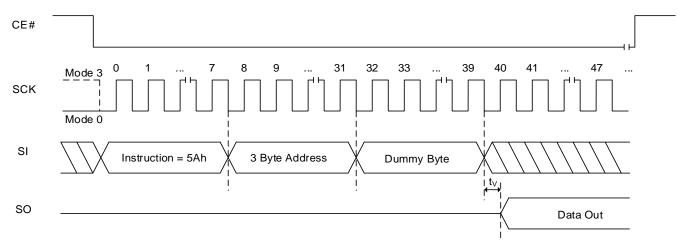
8.29 READ SFDP OPERATION (RDSFDP, 5Ah)

The Serial Flash Discoverable Parameters (SFDP) standard provides a consistent method of describing the functions and features of serial Flash devices in a standard set of internal parameter tables. These parameters can be interrogated by host system software to enable adjustments needed to accommodate divergent features from multiple vendors. For more details please refer to the JEDEC Standard JESD216A (Serial Flash Discoverable Parameters).

The sequence of issuing RDSFDP instruction is same as FAST_READ: CE# goes low \rightarrow Send RDSFDP instruction (5Ah) \rightarrow Send 3 address bytes on SI pin \rightarrow Send 1 dummy byte on SI pin \rightarrow Read SFDP code on SO \rightarrow End RDSFDP operation by driving CE# high at any time during data out. Refer to XMC's Application note for SFDP table. The data at the addresses that are not specified in SFDP table are undefined.

The sequence of RDSFDP instruction is same as FAST READ except for the instruction code. RDSFDP QPI sequence is also same as FAST READ QPI except for the instruction code. Refer to the FAST READ QPI operation.





8.30 NO OPERATION (NOP, 00h)

The No Operation command solely cancels a Reset Enable command and has no impact on any other commands. It is available in both SPI and QPI modes. To execute a NOP, the host drives CE# low, sends the NOP command cycle (00h), then drives CE# high.



8.31 SOFTWARE RESET (RESET-ENABLE (RSTEN, 66h) AND RESET (RST, 99h)) AND HARDWARE RESET

The Software Reset operation is used as a system reset that puts the device in normal operating mode. During the Reset operation, the value of volatile registers will default back to the value in the corresponding non-volatile register. This operation consists of two commands: Reset-Enable (RSTEN) and Reset (RST). The operation requires the Reset-Enable command followed by the Reset command. Any command other than the Reset command after the Reset-Enable command will disable the Reset-Enable.

Execute the CE# pin low → sends the Reset-Enable command (66h), and drives CE# high. Next, the host drives CE# low again, sends the Reset command (99h), and pulls CE# high.

Only for the dedicated parts that have the RESET# pin, Hardware Reset function is available. The RESET# pin will be solely applicable in SPI mode and when the QE bit is disabled. The RESET# pin has the highest priority among all the input signals and will reset the device to its initial power-on state regardless of the state of all other pins (CE#, IOs, SCK, and WP#).

In order to activate Hardware Reset, the RESET# pin must be driven low for a minimum period of t_{RESET} (1µs). Drive RESET# low for a minimum period of t_{RESET} will interrupt any on-going internal and external operations, release the device from deep power down mode¹, disable all input signals, force the output pin enter a state of high impedance, and reset all the read parameters. If the RESET# pulse is driven for a period shorter than 1µs, it may still reset the device, however the 1µs minimum period is recommended to ensure the reliable operation. The required wait time after activating a HW Reset before the device will accept another instruction (t_{HWRST}) is the same as the maximum value of t_{SUS} (100µs).

The Software/Hardware Reset during an active Program or Erase operation aborts the operation, which can result in corrupting or losing the data of the targeted address range. Depending on the prior operation, the reset timing may vary. Recovery from a Write operation will require more latency than recovery from other operations.

Note 1: The Status and Function Registers remain unaffected.

Figure 8.50 Software Reset Enable and Software Reset Sequence (RSTEN, 66h + RST, 99h)

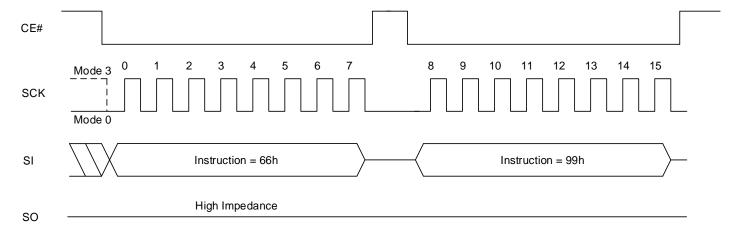
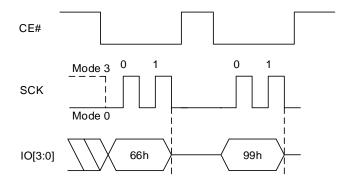




Figure 8.51 Software Reset Enable and Software Reset QPI Sequence (RSTEN, 66h + RST, 99h)



8.32 SECURITY INFORMATION ROW

The security Information Row is comprised of an additional 4 x 256 bytes of programmable information. The security bits can be reprogrammed by the user. Any program security instruction issued while an erase, program or write cycle is in progress is rejected without having any effect on the cycle that is in progress.

Table 8.6 Information Row Valid Address Range

Address Assignment	A[23:16]	A[15:8]	A[7:0]
IRL0 (Information Row Lock0)	00h	00h	Byte address
IRL1	00h	10h	Byte address
IRL2	00h	20h	Byte address
IRL3	00h	30h	Byte address

Bit 7~4 of the Function Register is used to permanently lock the programmable memory array.

When Function Register bit IRLx = "0", the 256 bytes of the programmable memory array can be programmed. When Function Register bit IRLx = "1", the 256 bytes of the programmable memory array function as read only.

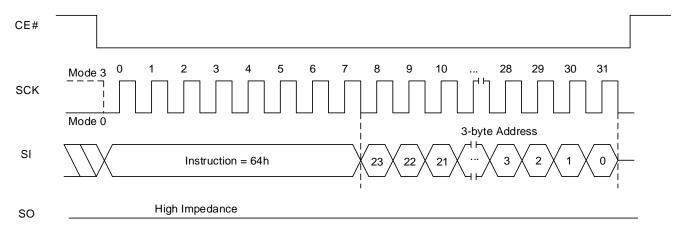


8.33 INFORMATION ROW ERASE OPERATION (IRER, 64h)

Information Row Erase (IRER) instruction erases the data in the Information Row x (x: 0~3) array. Prior to the operation, the Write Enable Latch (WEL) must be set via a Write Enable (WREN) instruction. The WEL bit is automatically reset after the completion of the operation.

The sequence of IRER operation: Pull CE# low to select the device → Send IRER instruction code → Send three address bytes → Pull CE# high. CE# should remain low during the entire instruction sequence. Once CE# is pulled high, Erase operation will begin immediately. The internal control logic automatically handles the erase voltage and timing.

Figure 8.52 IRER (Information Row Erase) Sequence





8.34 INFORMATION ROW PROGRAM OPERATION (IRP, 62h)

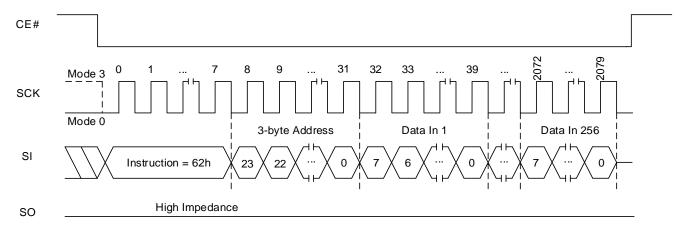
The Information Row Program (IRP) instruction allows up to 256 bytes data to be programmed into the memory in a single operation. Before the execution of IRP instruction, the Write Enable Latch (WEL) must be enabled through a Write Enable (WREN) instruction.

The IRP instruction code, three address bytes and program data (1 to 256 bytes) should be sequentially input. Three address bytes has to be input as specified in the Table 8.6 Information Row Valid Address Range. Program operation will start once the CE# goes high, otherwise the IRP instruction will not be executed. The internal control logic automatically handles the programming voltages and timing. During a program operation, all instructions will be ignored except the RDSR instruction. The progress or completion of the program operation can be determined by reading the WIP bit in Status Register via a RDSR instruction. If the WIP bit is "1", the program operation has completed.

If more than 256 bytes data are sent to a device, the address counter rolls over within the same page. The previously latched data are discarded and the last 256 bytes data are kept to be programmed into the page. The starting byte can be anywhere within the page. When the end of the page is reached, the address will wrap around to the beginning of the same page. If the data to be programmed are less than a full page, the data of all other bytes on the same page will remain unchanged.

Note: A program operation can alter "1"s into "0"s, but an erase operation is required to change "0"s back to "1"s. A byte cannot be reprogrammed without first erasing the corresponding Information Row array which is one of IR0~3.







8.35 INFORMATION ROW READ OPERATION (IRRD, 68h)

The IRRD instruction is used to read memory data at up to a 133MHz clock in the voltage range, 2.7V to 3.6V.

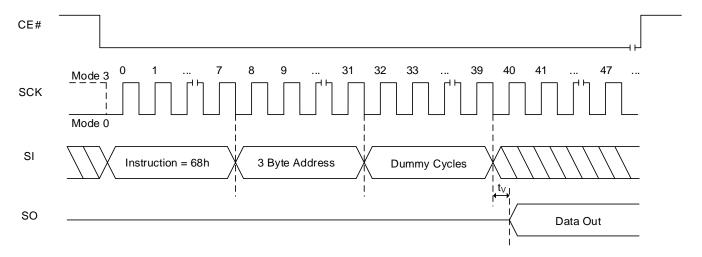
The IRRD instruction code is followed by three address bytes (A23 - A0) and a dummy byte, transmitted via the SI line, with each bit latched-in during the rising edge of SCK. Then the first data byte addressed is shifted out on the SO line, with each bit shifted out at a maximum frequency fc_T, during the falling edge of SCK.

The address is automatically incremented by one after each byte of data is shifted out. Once the address reaches the last address of each 256 byte Information Row, the next address will not be valid and the data of the address will be garbage data. It is recommended to repeat four times IRRD operation that reads 256 byte with a valid starting address of each Information Row in order to read all data in the 4 x 256 byte Information Row array. The IRRD instruction is terminated by driving CE# high (VIH).

If an IRRD instruction is issued while an Erase, Program or Write cycle is in process (WIP=1) the instruction is ignored and will not have any effects on the current cycle.

The sequence of IRRD instruction is same as FAST READ except for the instruction code. IRRD QPI sequence is also same as FAST READ QPI except for the instruction code. Refer to the FAST READ QPI operation.

Figure 8.54 IRRD (Information Row Read) Sequence





8.36 FAST READ DTR MODE OPERATION (FRDTR, 0Dh)

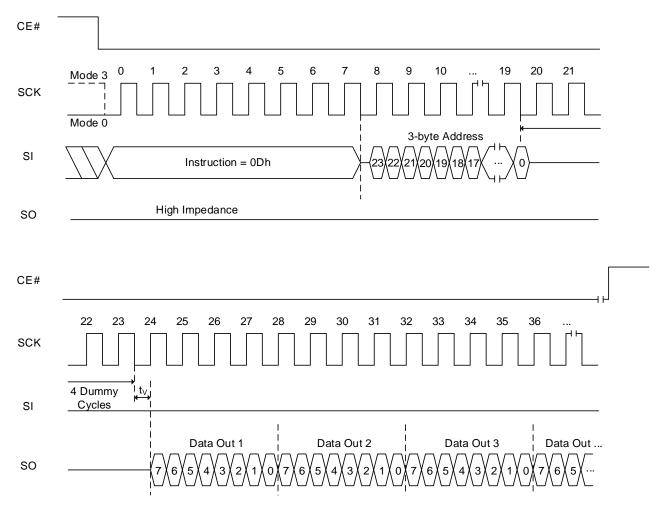
The FRDTR instruction is for doubling the data in and out. Signals are triggered on both rising and falling edge of clock. The address is latched on both rising and falling edge of SCK, and data of each bit shifts out on both rising and falling edge of SCK at a maximum frequency. The 2-bit address can be latched-in at one clock, and 2-bit data can be read out at one clock, which means one bit at the rising edge of clock, the other bit at the falling edge of clock.

The first address byte can be at any location. The address is automatically increased to the next higher address after each byte of data is shifted out, so the whole memory can be read out in a single FRDTR instruction. The address counter rolls over to 0 when the highest address is reached.

The sequence of issuing FRDTR instruction is: CE# goes low \rightarrow Sending FRDTR instruction code (1bit per clock) \rightarrow 3-byte address on SI (2-bit per clock) \rightarrow 4 dummy clocks on SI \rightarrow Data out on SO (2-bit per clock) \rightarrow End FRDTR operation via driving CE# high at any time during data out.

While a Program/Erase/Write Status Register cycle is in progress, FRDTR instruction will be rejected without any effect on the current cycle.

Figure 8.55 FRDTR Sequence





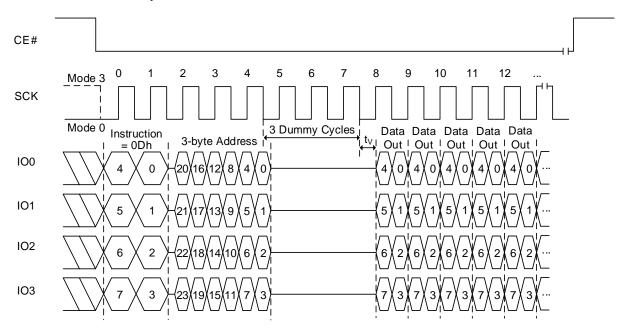
FAST READ DTR QPI MODE OPERATION (FRDTR QPI, 0Dh)

The FRDTR QPI instruction utilizes all four IO lines to input the instruction code so that only two clocks are required, while the FRDTR instruction requires that the byte-long instruction code is shifted into the device only via IO0 line in eight clocks. In addition, subsequent address and data out are shifted in/out via all four IO lines unlike the FRDTR instruction. Eventually this operation is same as the FRQDTR QPI, but the only different thing is that AX mode is not available in the FRDTR QPI operation.

The sequence of issuing FRDTR QPI instruction is: CE# goes low \rightarrow Sending FRDTR QPI instruction (4-bit per clock) \rightarrow 24-bit address interleave on IO3, IO2, IO1 & IO0 (8-bit per clock) \rightarrow 3 dummy clocks (configurable, default is 3 clocks) \rightarrow Data out interleave on IO3, IO2, IO1 & IO0 (8-bit per clock) \rightarrow End FRDTR QPI operation by driving CE# high at any time during data out.

If the FRDTR QPI instruction is issued while a Program/Erase/Write Status Register cycle is in progress (WIP=1), the instruction will be rejected without any effect on the current cycle.

Figure 8.56 FRDTR QPI Sequence



- 1. Number of dummy cycles depends on clock speed. Detailed information in Table 6.10 Read Dummy Cycles.
- 2. Sufficient dummy cycles are required to avoid I/O contention.



8.37 FAST READ DUAL IO DTR MODE OPERATION (FRDDTR, BDh)

The FRDDTR instruction enables Double Transfer Rate throughput on dual I/O of the device in read mode. The address (interleave on dual I/O pins) is latched on both rising and falling edge of SCK, and the data (interleave on dual I/O pins) shift out on both rising and falling edge of SCK at a maximum frequency. The 4-bit address can be latched-in at one clock, and 4-bit data can be read out at one clock, which means two bits at the rising edge of clock, the other two bits at the falling edge of clock.

The first address byte can be at any location. The address is automatically increased to the next higher address after each byte of data is shifted out, so the whole memory can be read out with a single FRDDTR instruction. The address counter rolls over to 0 when the highest address is reached. Once writing FRDDTR instruction, the following address/dummy/data out will perform as 4-bit instead of previous 1-bit.

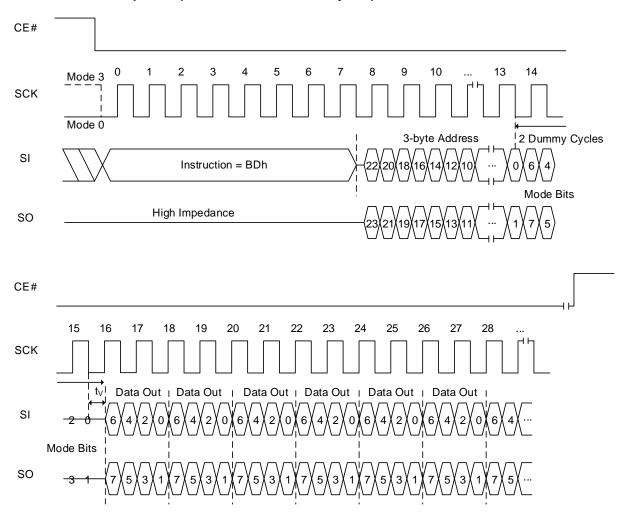
The sequence of issuing FRDDTR instruction is: CE# goes low \rightarrow Sending FRDDTR instruction (1-bit per clock) \rightarrow 24-bit address interleave on IO1 & IO0 (4-bit per clock) \rightarrow 2 dummy clocks (configurable, default is 2 clocks) on IO1 & IO0 \rightarrow Data out interleave on IO1 & IO0 (4-bit per clock) \rightarrow End FRDDTR operation via pulling CE# high at any time during data out (Please refer to Figure 8.57 for 2 x I/O Double Transfer Rate Read Mode Timing Waveform).

If AXh (where X is don't care) is input for the mode bits during dummy cycles, the device will enter AX read operation mode which enables subsequent FRDDTR execution skips command code. It saves cycles as described in Figure 8.58. When the code is different from AXh, the device exits the AX read operation. After finishing the read operation, device becomes ready to receive a new command. Since the number of dummy cycles and AX bit cycles are same in this case, X should be Hi-Z to avoid I/O contention

If the FRDDTR instruction is issued while a Program/Erase/Write Status Register cycle is in progress (WIP=1), the instruction will be rejected without any effect on the current cycle.



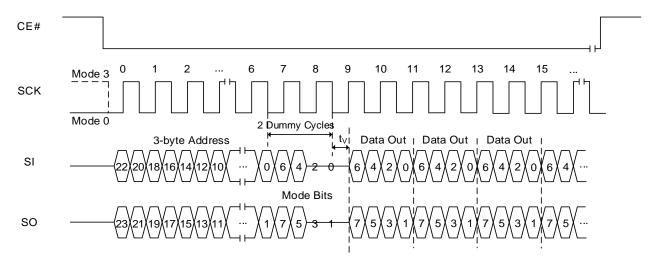
Figure 8.57 FRDDTR Sequence (with command decode cycles)



- 1. If the mode bits=AXh (where X is don't care), it can execute the AX read mode (without command). When the mode bits are different from AXh, the device exits the AX read operation.
- 2. Number of dummy cycles depends on clock speed. Detailed information in Table 6.10 Read Dummy Cycles.
- 3. Since the number of dummy cycles and AX bit cycles are same in the above Figure, X should be Hi-Z to avoid I/O contention.



Figure 8.58 FRDDTR AX Read Sequence (without command decode cycles)



- 1. If the mode bits=AXh (where X is don't care), it will keep executing the AX read mode (without command). When the mode bits are different from AXh, the device exits the AX read operation.
- 2. Number of dummy cycles depends on clock speed. Detailed information in Table 6.10 Read Dummy Cycles.
- 3. Since the number of dummy cycles and AX bit cycles are same in the above Figure, X should be Hi-Z to avoid I/O contention



8.38 FAST READ QUAD IO DTR MODE OPERATION (FRQDTR, EDh)

The FRQDTR instruction enables Double Transfer Rate throughput on quad I/O of the device in read mode.

A Quad Enable (QE) bit of Status Register must be set to "1" before sending the FRQDTR instruction.

The address (interleave on 4 I/O pins) is latched on both rising and falling edge of SCK, and data (interleave on 4 I/O pins) shift out on both rising and falling edge of SCK at a maximum frequency. The 8-bit address can be latched-in at one clock, and 8-bit data can be read out at one clock, which means four bits at the rising edge of clock, the other four bits at the falling edge of clock.

The first address byte can be at any location. The address is automatically increased to the next higher address after each byte data is shifted out, so the whole memory can be read out with a single FRQDTR instruction. The address counter rolls over to 0 when the highest address is reached. Once writing FRQDTR instruction, the following address/dummy/data out will perform as 8-bit instead of previous 1-bit.

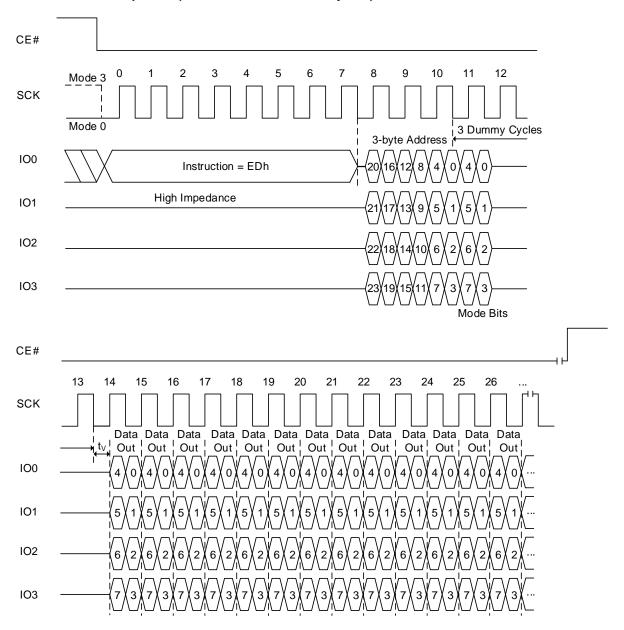
The sequence of issuing FRQDTR instruction is: CE# goes low \rightarrow Sending FRQDTR instruction (1-bit per clock) \rightarrow 24-bit address interleave on IO3, IO2, IO1 & IO0 (8-bit per clock) \rightarrow 3 dummy clocks (configurable, default is 3 clocks) \rightarrow Data out interleave on IO3, IO2, IO1 & IO0 (8-bit per clock) \rightarrow End FRQDTR operation by driving CE# high at any time during data out.

If AXh (where X is don't care) is input for the mode bits during dummy cycles, the device will enter AX read operation mode which enables subsequent FRQDTR execution skips command code. It saves cycles as described in Figure 8.60. When the code is different from AXh, the device exits the AX read operation. After finishing the read operation, device becomes ready to receive a new command.

If the FRQDTR instruction is issued while a Program/Erase/Write Status Register cycle is in progress (WIP=1), the instruction will be rejected without any effect on the current cycle.



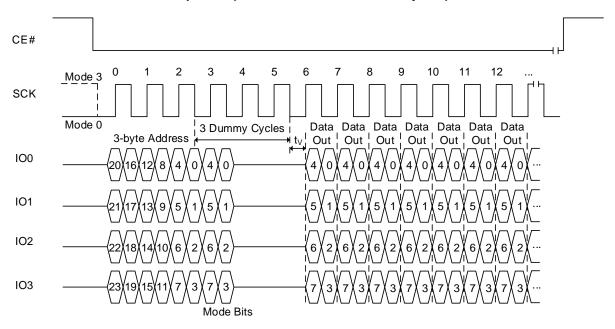
Figure 8.59 FRQDTR Sequence (with command decode cycles)



- 1. If the mode bits=AXh (where X is don't care), it can execute the AX read mode (without command). When the mode bits are different from AXh, the device exits the AX read operation.
- 2. Number of dummy cycles depends on clock speed. Detailed information in Table 6.10 Read Dummy Cycles.
- 3. Sufficient dummy cycles are required to avoid I/O contention. If the number of dummy cycles and AX bit cycles are same, then X should be Hi-Z.



Figure 8.60 FRQDTR AX Read Sequence (without command decode cycles)



- 1. If the mode bits=AXh (where X is don't care), it will keep executing the AX read mode (without command). When the mode bits are different from AXh, the device exits the AX read operation.
- 2. Number of dummy cycles depends on clock speed. Detailed information in Table 6.10 Read Dummy Cycles.
- 3. Sufficient dummy cycles are required to avoid I/O contention. If the number of dummy cycles and AX bit cycles are same, then X should be Hi-Z.



FAST READ QUAD IO DTR QPI MODE OPERATION (FRQDTR QPI, EDh)

The FRQDTR QPI instruction utilizes all four IO lines to input the instruction code so that only two clocks are required, while the FRQDTR instruction requires that the byte-long instruction code is shifted into the device only via IO0 line in eight clocks. As a result, 6 command cycles will be reduced by the FRQDTR QPI instruction. In addition, subsequent address and data out are shifted in/out via all four IO lines like the FRQDTR instruction. In fact, except for the command cycle, the FRQDTR QPI operation is exactly same as the FRQDTR.

It is not required to set QE bit to "1".before Fast Read Quad I/O DTR instruction in QPI mode.

The sequence of issuing FRQDTR QPI instruction is: CE# goes low \rightarrow Sending FRQDTR QPI instruction (4-bit per clock) \rightarrow 24-bit address interleave on IO3, IO2, IO1 & IO0 (8-bit per clock) \rightarrow 3 dummy clocks (configurable, default is 3 clocks) \rightarrow Data out interleave on IO3, IO2, IO1 & IO0 (8-bit per clock) \rightarrow End FRQDTR QPI operation by driving CE# high at any time during data out.

If AXh (where X is don't care) is input for the mode bits during dummy cycles, the device will enter AX read operation mode which enables subsequent FRQDTR QPI execution skips command code. It saves cycles as described in Figure 8.60. When the code is different from AXh, the device exits the AX read operation. After finishing the read operation, device becomes ready to receive a new command.

If the FRQDTR QPI instruction is issued while a Program/Erase/Write Status Register cycle is in progress (WIP=1), the instruction will be rejected without any effect on the current cycle.

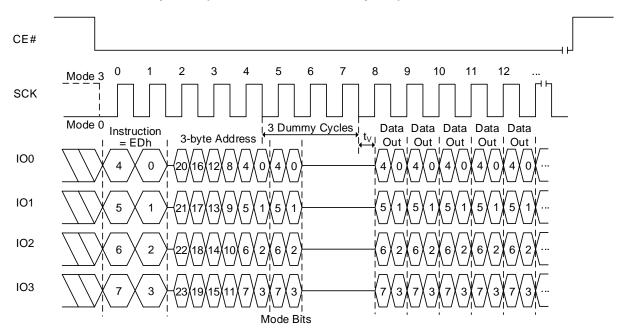


Figure 8.61 FRQDTR QPI Sequence (with command decode cycles)

- 1. If the mode bits=AXh (where X is don't care), it can execute the AX read mode (without command). When the mode bits are different from AXh, the device exits the AX read operation.
- 2. Number of dummy cycles depends on clock speed. Detailed information in Table 6.10 Read Dummy Cycles.
- 3. Sufficient dummy cycles are required to avoid I/O contention. If the number of dummy cycles and AX bit cycles are same, then X should be Hi-Z.



8.39 SECTOR LOCK/UNLOCK FUNCTIONS

SECTOR UNLOCK OPERATION (SECUNLOCK, 26h)

The Sector Unlock command allows the user to select a specific sector to allow program and erase operations. This instruction is effective when the blocks are designated as write-protected through the BP0, BP1, BP2, and BP3 bits in the Status Register. Only one sector can be enabled at any time. To enable a different sector, a previously enabled sector must be disabled by executing a Sector Lock command. The instruction code is followed by a 24-bit address specifying the target sector, but A0 through A11 are not decoded. The remaining sectors within the same block remain as read-only.

Figure 8.62 Sector Unlock Sequence

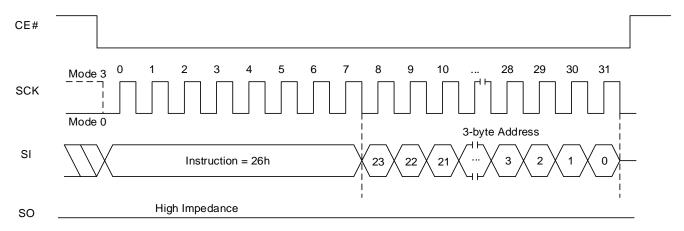
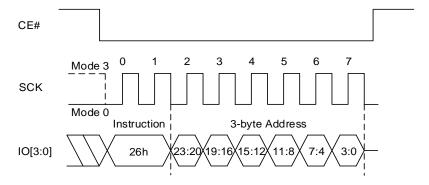


Figure 8.63 Sector Unlock QPI Sequence





SECTOR LOCK OPERATION (SECLOCK, 24h)

The Sector Lock command relocks a sector that was previously unlocked by the Sector Unlock command. The instruction code does not require an address to be specified, as only one sector can be enabled at a time. The remaining sectors within the same block remain in read-only mode.

Figure 8.64 Sector Lock Sequence

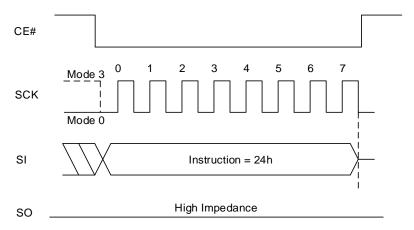
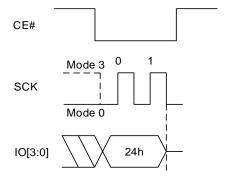


Figure 8.65 Sector Lock QPI Sequence





9. ELECTRICAL CHARACTERISTICS

9.1 ABSOLUTE MAXIMUM RATINGS (1)

Storage Temperature	-65°C to +150°C	
Surface Mount Load Soldering Tomperature	Standard Package	240°C 3 Seconds
Surface Mount Lead Soldering Temperature	Lead-free Package	260°C 3 Seconds
Input Voltage with Respect to Ground on All Pins	-0.5V to V _{CC} + 0.5V	
All Output Voltage with Respect to Ground	-0.5V to V _{CC} + 0.5V	
Vcc	-0.5V to +6.0V	
Electrostatic Discharge Voltage (Human Body Model) (2)	-2000V to +2000V	

Note:

- 1. Applied conditions greater than those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- 2. ANSI/ESDA/JEDEC JS-001

9.2 OPERATING RANGE

Part Number	XM25QH128B
Operating Temperature (Industrial)	-40°C to 85°C
V Power Cupply	2.7V (VMIN) – 3.6V (VMAX); 3.0V (Typ), Max. 133MHz
V _{CC} Power Supply	2.3V (VMIN) - 3.6V (VMAX); 3.0V (Typ), Max. 104MHz



9.3 DC CHARACTERISTICS

(Under operating range)

Symbol	Parameter	Condition	1	Min	Typ ⁽²⁾	Max	Units
		NORD at 50MHz,			5	9	
	V _{CC} Active Read current ⁽³⁾	FRD Single at 133MHz			7	11	
I _{CC1}	V _{CC} Active Read current	FRD Quad at 133MHz			10	14	
		FRD Quad DTR at 66MHz			10	14	
			85°C			20 ⁽⁴⁾	
I_{CC2}	I _{CC2} V _{CC} Program Current	CE# = V _{CC}	105°C		17	22 ⁽⁴⁾	
			125°C			25	
			85°C			20 ⁽⁴⁾	A
I_{CC3}	V _{CC} WRSR Current	CE# = V _{CC}	105°C		17	22 ⁽⁴⁾	mA
			125°C			25	
			85°C			20 ⁽⁴⁾	
I_{CC4}	I _{CC4} V _{CC} Erase Current (SER/BER32K/BER64K)	CE# = V _{CC}	105°C		17	22 ⁽⁴⁾	
			125°C			25	
			85°C		17	20 ⁽⁴⁾	
I _{CC5}	V _{CC} Erase Current (CE)	CE# = V _{CC}	105°C			22 ⁽⁴⁾	
			125°C			25	
			85°C			20 ⁽⁴⁾	
I _{SB1}	V _{CC} Standby Current CMOS	$V_{CC} = VMAX, CE# = V_{CC}$	105°C		10	45 ⁽⁴⁾	
	Civioo		125°C			65	
			85°C			10 ⁽⁴⁾	
I_{SB2}	Deep power down current	$V_{CC} = VMAX, CE# = V_{CC}$	105°C		5	25 ⁽⁴⁾	μA
			125°C			30	
ILI	Input Leakage Current	$V_{IN} = 0V \text{ to } V_{CC}$				1	
I _{LO}	Output Leakage Current	$V_{IN} = 0V \text{ to } V_{CC}$				1	
V _{IL} ⁽¹⁾	Input Low Voltage			-0.5		0.3V _{CC}	
V _{IH} ⁽¹⁾	Input High Voltage			0.7V _{CC}		V _{CC} + 0.3	/
V _{OL}	Output Low Voltage	\/MINL	I _{OL} = 100 μA			0.2	V
V _{OH}	Output High Voltage	VMIN < V _{CC} < VMAX	I _{OH} = -100 μA	V _{CC} - 0.2			

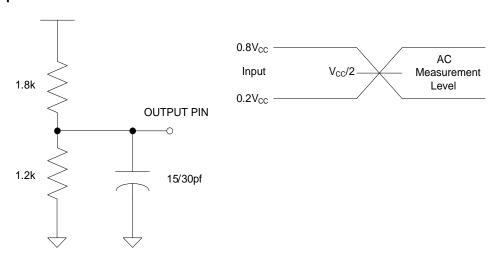
- Maximum DC voltage on input or I/O pins is V_{CC} + 0.5V. During voltage transitions, input or I/O pins may overshoot V_{CC} by +2.0V for a period of time not to exceed 20ns. Minimum DC voltage on input or I/O pins is -0.5V. During voltage transitions, input or I/O pins may undershoot GND by -2.0V for a period of time not to exceed 20ns.
- 2. Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at $V_{CC} = V_{CC}$ (Typ), TA=25°C.
- 3. Outputs are unconnected during reading data so that output switching current is not included.
- 4. These parameters are characterized and are not 100% tested.



9.4 AC MEASUREMENT CONDITIONS

Symbol	Parameter	Min	Max	Units
CI	Load Capacitance up to 104MHz		30	pF
CL Load Capacitance up to 133MHz			15	pF
TR,TF	Input Rise and Fall Times		5	ns
VIN	Input Pulse Voltages	0.2V _{CC} to 0.8V _{CC}		V
VREFI	Input Timing Reference Voltages	0.3V _{CC} to 0.7V _{CC}		V
VREFO	Output Timing Reference Voltages	0.5	Vcc	V

Figure 9.1 Output test load & AC measurement I/O Waveform



9.5 PIN CAPACITANCE (TA = 25°C, VCC=3V, 1MHZ)

Symbol	Parameter	Test Condition	Min	Тур	Max	Units
C _{IN}	Input Capacitance (CE#, SCK)	V _{IN} = 0V	-	-	6	pF
C _{IN/OUT}	Input/Output Capacitance (other pins)	V _{IN/OUT} = 0V	-	-	8	pF

Notes:

1. These parameters are characterized and are not 100% tested.



9.6 AC CHARACTERISTICS

(Under operating range, refer to section 9.4 for AC measurement conditions)

Symbol	Parameter			Min	Typ ⁽³⁾	Max	Units	
	Clock Frequency except for fast	read	Vcc=2.7V~3.6V	0		133	MHz	
f _{CT}	DTR and read (03h)	DTR and read (03h) Vcc=2.3V~3.6V		0		104	MHz	
	Clock Frequency for fast read D SPI DTR, Dual DTR, Dual I/O D QPI DTR.	DTR, Dual DTR, Dual I/O DTR, Quad I/O DTR, and		0		66	MHz	
f _C	Clock Frequency for read (03h)			0		50	MHz	
t _{CLCH} ⁽¹⁾	SCK Rise Time (peak to peak)			0.1			V/ns	
t _{CHCL} ⁽¹⁾	SCK Fall Time (peak to peak)			0.1			V/ns	
t	SCK High Time		ıd (03h)	0.45 x 1/f _{Cmax}			ne	
t _{CKH}	SCK High Time	SCK High Time For others		0.45 x 1/f _{CTmax}			ns	
tour	SCK Low Time	For rea	id (03h)	0.45 x 1/f _{Cmax}			ne	
t _{CKL}	SCK LOW TITTLE	For oth	ers	0.45 x 1/f _{CTmax}			ns	
t _{CEH}	CE# High Time			7			ns	
t _{CS}	CE# Setup Time			6			ns	
t _{CH}	CE# Hold Time			6			ns	
4	Data In Setup Time		STR	2			ns	
t _{DS}			DTR	1.5			110	
4	Data in Hald Time		STR	2			no	
t _{DH}	Data in Hold Time		DTR	1.5			ns	
4	Output Valid	@ 1331	MHz (CL = 15pF)			7	no	
t _V	Output Valid	@ 104	MHz (CL = 30pF)			8	ns	
t _{OH}	Output Hold Time			2			ns	
t _{DIS} ⁽¹⁾	Output Disable Time					8	ns	
t _{HLCH}	HOLD Active Setup Time relative	e to SC	K	5			ns	
t _{CHHH}	HOLD Active Hold Time relative	to SCK		5			ns	
t _{HHCH}	HOLD Not Active Setup Time re	lative to	SCK	5			ns	
t _{CHHL}	HOLD Not Active Hold Time rela	ative to	SCK	5			ns	
t _{LZ} ⁽¹⁾	HOLD to Output Low Z					12	ns	
t _{HZ} ⁽¹⁾	HOLD to Output High Z					12	ns	
	Sector Erase Time (4Kbyte)				70	300	ms	
4	Block Erase Time (32Kbyte)	+			0.1	0.5	s	
t _{EC}	Block Erase time (64Kbyte)				0.15	1.0	S	
	Chip Erase Time				30	90	S	
t _{PP}	Page Program Time				0.2	0.8	ms	



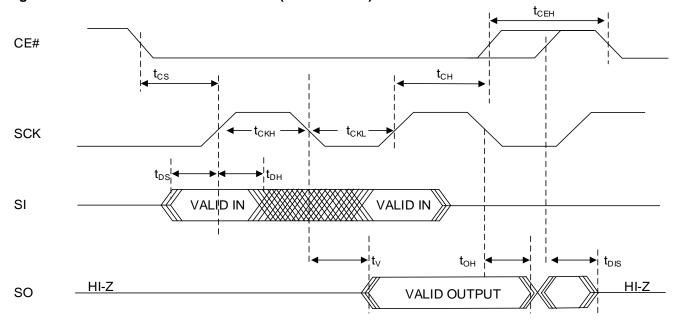
Symbol	Parameter	Min	Typ ⁽³⁾	Max	Units
t _{RES1} ⁽¹⁾	Release deep power down			3	μs
t _{DP} ⁽¹⁾	Deep power down			3	μs
t _W	Write Status Register time		2	15	ms
t _{SUS} ⁽¹⁾	Suspend to read ready			100	μs
t _{SRST} ⁽¹⁾	Software Reset recovery time			100	μs
t _{RESET} (1),(4)	RESET# pin low pulse width	1 ⁽²⁾			μs
t _{HWRST} (1),(4)	Hardware Reset recovery time			100	μs

- 1. These parameters are characterized and not 100% tested.
- 2. If the RESET# pulse is driven for a period shorter than 1µs (t_{RESET} minimum), it may still reset the device, however the 1µs minimum period is recommended to ensure reliable operation.
- 3. Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at $V_{CC} = V_{CC}$ (Typ), TA=25°C.
- 4. Only applicable to the parts that have the RESET# pin option.



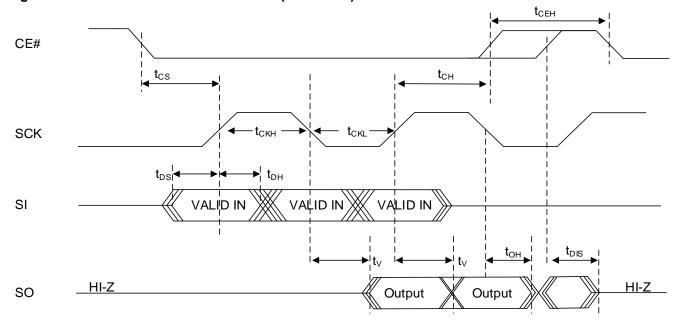
9.7 SERIAL INPUT/OUTPUT TIMING

Figure 9.2 SERIAL INPUT/OUTPUT TIMING (Normal Mode) (1)



Note1. For SPI Mode 0 (0,0)

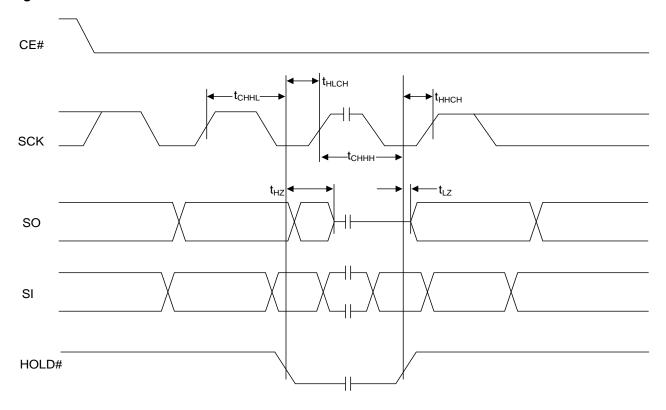
Figure 9.3 SERIAL INPUT/OUTPUT TIMING (DTR Mode) (1)



Note1. For SPI Mode 0 (0,0)



Figure 9.4 HOLD TIMING

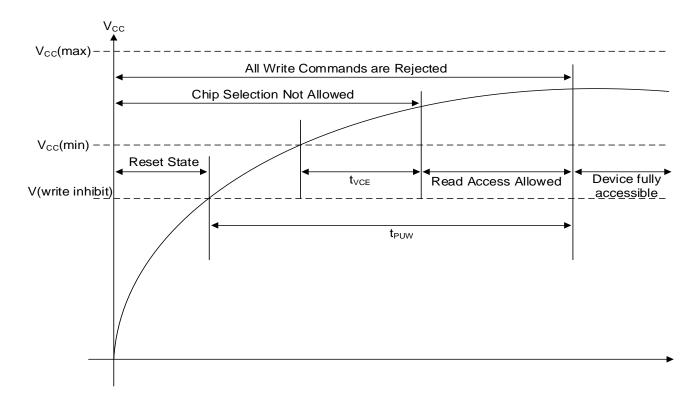




9.8 POWER-UP AND POWER-DOWN

At Power-up and Power-down, the device must be NOT SELECTED until Vcc reaches at the right level. (Adding a simple pull-up resistor on CE# is recommended.)

Power up timing



Symbol	Parameter	Min.	Max	Unit
tVCE ⁽¹⁾	Vcc(min) to CE# Low	1		ms
tPUW ⁽¹⁾	Power-up time delay to write instruction	1	10	ms
$V_{WI}^{(1)}$	Write Inhibit Voltage		2.1	V

Note: These parameters are characterized and not 100% tested.



9.9 PROGRAM/ERASE PERFORMANCE

Parameter	Тур	Max	Unit
Sector Erase Time (4Kbyte)	70	300	ms
Block Erase Time (32Kbyte)	0.1	0.5	S
Block Erase Time (64Kbyte)	0.15	1.0	S
Chip Erase Time	30	90	S
Page Programming Time	0.2	0.8	ms
Byte Program	8	40	μs

Note: These parameters are characterized and not 100% tested.

9.10 RELIABILITY CHARACTERISTICS

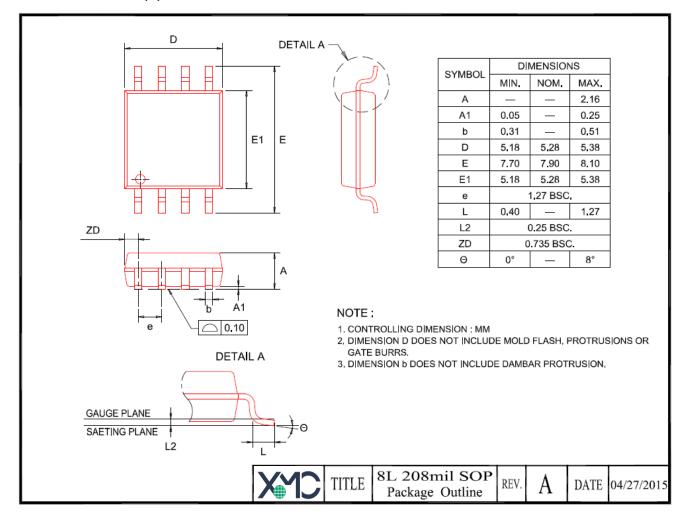
Parameter	Min	Max	Unit	Test Method
Endurance	100,000	-	Cycles	JEDEC Standard A117
Data Retention	20	-	Years	JEDEC Standard A117
Latch-Up	-100	+100	mA	JEDEC Standard 78

Note: These parameters are characterized and not 100% tested.



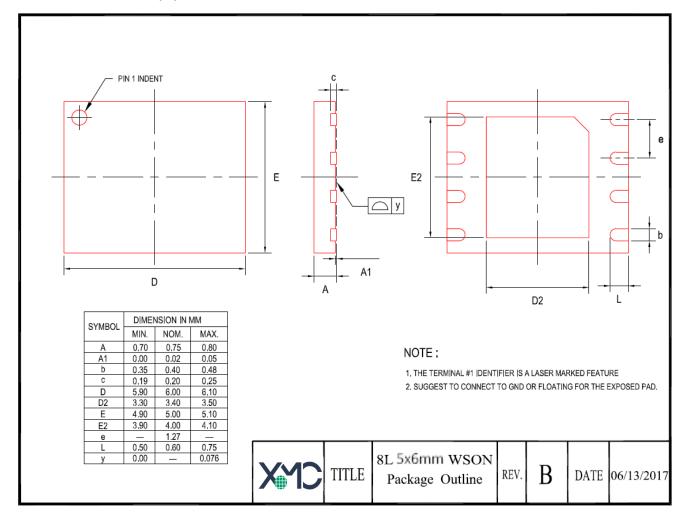
10. PACKAGE TYPE INFORMATION

10.1 SOP 208MIL 8L (H)



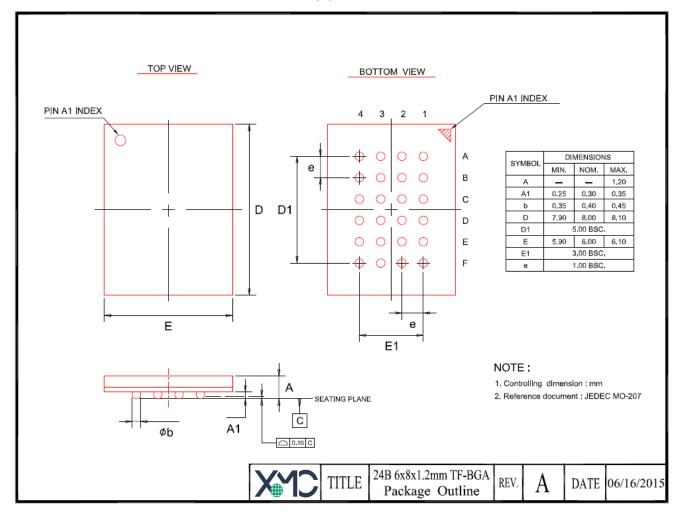


10.2 WSON 5X6MM 8L (W)



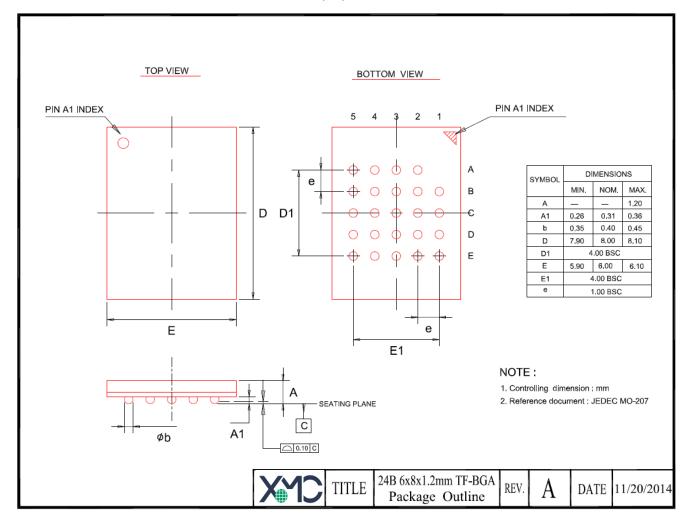


10.3 TFBGA 6X8MM 24-BALL 4X6 BALL ARRAY (B)



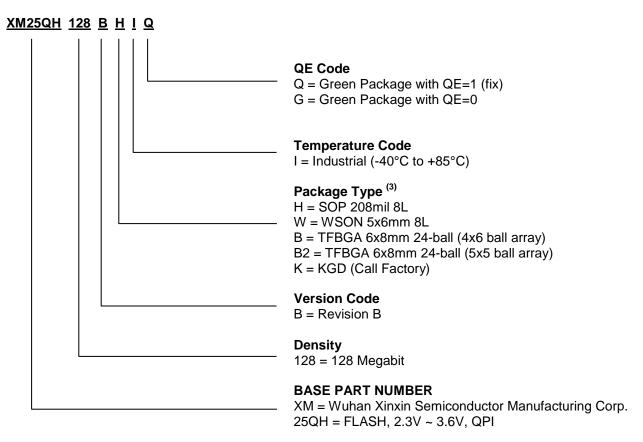


10.4 TFBGA 6X8MM 24-BALL 5X5 BALL ARRAY (B2)





11. ORDERING INFORMATION- Valid Part Numbers



Note:

1. For more information, please contact XMC sales..



REVISION LIST

Version No.	Description	Date
0.1	Initial Release	2019/03/21
0.2	Remove Preliminary	2019/09/20
0.3	Update SFDP	2019/12/04
0.4	Update ordering information	2020/05/27